

PCTEST ENGINEERING LABORATORY, INC.

7185 Oakland Mills Road, Columbia, MD 21046 USA Tel. 410.290.6652 / Fax 410.290.6654 http://www.pctest.com



HEARING AID COMPATIBILITY

Applicant Name:

LG Electronics U.S.A, Inc. 1000 Sylvan Avenue Englewood Cliffs, NJ 07632 United States Date of Testing: 5/27/2019 - 6/06/2019 Test Site/Location: PCTEST Lab, Columbia, MD, USA Test Report Serial No.: 1M1905210083-08-R1.ZNF Date of Issue: 6/17/2019

FCC ID:

ZNFX320APM

RF Emissions Testing

APPLICANT:

LG ELECTRONICS U.S.A, INC.

Scope of Test: Application Type: FCC Rule Part(s): HAC Standard:

DUT Type: Model: Additional Model(s): Certification CFR §20.19(b) ANSI C63.19-2011 285076 D01 HAC Guidance v05 285076 D02 T-Coil testing for CMRS IP v03 Portable Handset LM-X320APM LMX320APM, X320APM, LM-X320AM8, LMX320AM8, X320AM8, LM-X320CM, LMX320CM, X320CM *Pre-Production Sample* [S/N: 02105]

Test Device Serial No.:

C63.19-2011 HAC Category:

M3 (RF EMISSIONS CATEGORY)

Note: This revised Test Report (S/N: 1M1905210083-08-R1.ZNF) supersedes and replaces the previously issued test report on the same subject device for the same type of testing as indicated. Please discard or destroy the previously issued test report(s) and dispose of it accordingly.

This wireless portable device has been shown to be hearing-aid compatible under the above rated category, specified in ANSI/IEEE Std. C63.19-2011 and has been tested in accordance with the specified measurement procedures. Hearing-Aid Compatibility is based on the assumption that all production units will be designed electrically identical to the device tested in this report. Test results reported herein relate only to the item(s) tested. North America bands only.

I attest to the accuracy of data. All measurements reported herein were performed by me or were made under my supervision and are correct to the best of my knowledge and belief. I assume full responsibility for the completeness of these measurements and vouch for the qualifications of all persons taking them.

Randy Ortanez President



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1. INTRODUCTION

On July 10, 2003, the Federal Communications Commission (FCC) adopted new rules requiring wireless manufacturers and service providers to provide digital wireless phones that are compatible with hearing aids. The FCC has modified the exemption for wireless phones under the Hearing Aid Compatibility Act of 1998 (HAC Act) in WT Docket 01-309 RM-8658¹ to extend the benefits of wireless telecommunications to individuals with hearing disabilities. These benefits encompass business, social and emergency communications, which increase the value of the wireless network for everyone. An estimated more than 10% of the population in the United States show signs of hearing impairment and of that fraction, almost 80% use hearing aids. Approximately 500 million people worldwide suffer from hearing loss.

Compatibility Tests Involved:

The standard calls for wireless communications devices to be measured for:

- RF Electric-field emissions
- T-coil mode, magnetic-signal strength in the audio band
- T-coil mode, magnetic-signal frequency response through the audio band
- T-coil mode, magnetic-signal and noise articulation index

The hearing aid must be measured for:

- RF immunity in microphone mode
- RF immunity in T-coil mode

In the following tests and results, this report includes the evaluation for a wireless communications device.



Figure 1-1 Hearing Aid *in-vitu*

¹ FCC Rule & Order, WT Docket 01-309 RM-8658

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2. DUT DESCRIPTION



FCC ID:	ZNFX320APM
Manufacturer:	LG Electronics U.S.A, Inc.
	1000 Sylvan Avenue
	Englewood Cliffs, NJ 07632
	United States
Model:	LM-X320APM
Additional Model(s):	LMX320APM, X320APM, LM-X320AM8, LMX320AM8, X320AM8, LM-X320CM, LMX320CM, X320CM
Serial Number:	02105
Antenna Configurations:	Internal Antenna
DUT Type:	Portable Handset

Table 2-1ZNFX320APM HAC Air Interfaces

Air-Interface	Band (MHz)	Type Transport	HAC Tested	Simultaneous But Not Tested	Name of Voice Service
	850	vo	Yes	Yes: WIFI or BT	CMRS Voice
GSM	1900	VO	163	Tes. WIT OF BI	civility voice
	GPRS/EDGE	VD	No ¹	Yes: WIFI or BT	Google Duo
	850				
UMTS	1700	VD	No ¹	Yes: WIFI or BT	CMRS Voice
UIVITS	1900				
	HSPA	VD	No ¹	Yes: WIFI or BT	Google Duo
	700 (B12)				
	790 (B14)				
LTE (FDD)	850 (B5)	VD	No ¹	Yes: WIFI or BT	VoLTE, Google Duo
	1700 (B4)	•			
	1900 (B2)				
WIFI	2450	VD	No ¹	Yes: GSM, UMTS, or LTE	VoWIFI, Google Duo
BT	2450	DT	No	Yes: GSM, UMTS, or LTE	N/A
-			Notes: 1. Evaluated fo	or MIF and low-power exemption.	

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3. ANSI/IEEE C63.19 PERFORMANCE CATEGORIES

I. RF EMISSIONS

The ANSI Standard presents performance requirements for acceptable interoperability of hearing aids with wireless communications devices. When these parameters are met, a hearing aid operates acceptably in close proximity to a wireless communications device.

Category	Telephone RF Parameters	
Near field Category	E-field emissions CW dB(V/m)	
	f < 960 MHz	
M1	50 to 55	
M2	45 to 50	
M3	40 to 45	
M4	< 40	
f > 960 MHz		
M1	40 to 45	
M2	35 to 40	
M3	30 to 35	
M4	< 30	
Table 3-1WD near-field categories as defined in ANSI C63.19-2011		

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4. SYSTEM SPECIFICATIONS

EF3DV3 E-Field Probe Description

Construction:	One dipole parallel, two dipoles normal to probe axis
Calibration:	Built-in shielding against static charges In air from 30 MHz to 6.0 GHz (absolute accuracy ±5.1%, k=2)
Frequency:	30 MHz to > 6 GHz;
	Linearity: ± 0.2 dB (30 MHz to 6 GHz)
Directivity	± 0.2 dB in air (rotation around probe axis)
	± 0.4 dB in air (rotation normal to probe axis)
Dynamic Range	2 V/m to > 1000 V/m
	(M3 or better device readings fall well below diode
	compression point)
Linearity:	± 0.2 dB
Dimensions	Overall length: 337 mm (Tip: 20 mm)
	Tip diameter: 4.0 mm (Body: 12 mm)
	Distance from probe tip to dipole centers: 1.5 mm

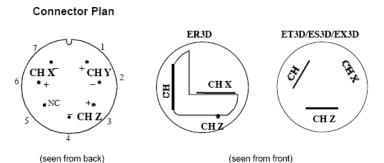


Figure 4-1 E-field Free-space Probe

Probe Tip Description

HAC field measurements take place in the close near field with high gradients. Increasing the measuring distance from the source will generally decrease the measured field values (in case of the validation dipole approx. 10% per mm).

The electric field probes have an irregular internal geometry because it is physically not possible to have the 3 orthogonal sensors situated with the same center. The effect of the different sensor centers is accounted for in the HAC uncertainty budget ("sensor displacement").



The antistatic shielding inside the probe is connected to the probe connector case.

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Instrumentation Chain

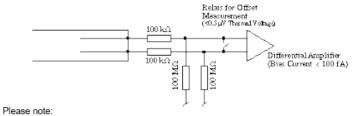
Equation 1 Conversion of Connector Voltage u_i to E-Field E_i

$$E_i = \sqrt{\frac{u_i + (u_i^2 \cdot CF)/(DCP)}{Norm_i \cdot ConvF}}$$

whereby

Ei:	electric field in V/m
Uj.	voltage of channel i at the connector in μV
Norm	sensitivity of channel i in μV/(V/m) ²
ConvF:	enhancement factor in liquid (ConvF=1 for Air)
DCP:	diode compression point in µV
CF:	signal crest factor (peak power/average power)

Conditions of Calibration



a lower input impedance of the amplifier will result in different sensitivity factors Norm, and DCP

larger bias currents will cause higher offset

Probe Response to Frequency

The E-field sensors have inherently a very flat frequency response. They are calibrated with a number of frequencies resulting in a common calibration factor, with the frequency behavior documented in the calibration certificate (See also below).

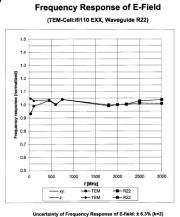


Figure 4-2 E-Field Probe Frequency Response

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SPEAG Robotic System

E-field measurements are performed using the DASY5 automated dosimetric assessment system. The DASY5 is made by Schmid & Partner Engineering AG (SPEAG) in Zurich, Switzerland and consists of high precision robotics system (Staubli), robot controller, Intel CORE i7 computer, near-field probe, probe alignment sensor, and the HAC phantom. The robot is a six-axis industrial robot performing precise movements to position the probe to the location (points) of maximum electromagnetic field (EMF).



Figure 4-3 SPEAG Robotic System

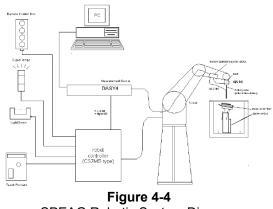
System Hardware

A cell controller system contains the power supply, robot controller, teach pendant (Joystick), and a remote control used to drive the robot motors. The PC consists of the computer with operating system and RF Measurement Software DASY5 v52.8 (with HAC Extension), A/D interface card, monitor, mouse, and keyboard. The Staubli Robot is connected to the cell controller to allow software manipulation of the robot. A data acquisition electronic (DAE) circuit that performs the signal amplification, signal multiplexing, AD-conversion, offset measurements, mechanical surface detection, collision detection, etc. is connected to the Electro-optical coupler (EOC). The EOC performs the conversion from the optical into digital electric signal of the DAE and transfers data to the PC plug-in card.

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System Electronics

The DAE consists of a highly sensitive electrometer-grade preamplifier with auto-zeroing, a channel and gain-switching multiplexer, a fast 16 bit AD-converter and a command decoder and control logic unit. Transmission to the PC-card is accomplished through an optical downlink for data and status information and an optical uplink for commands and clock lines. The mechanical probe mounting device includes two different sensor systems for frontal and sidewise probe contacts. They are also used for mechanical surface detection and probe collision detection. The robot uses its own controller with a built in VME-bus computer.



SPEAG Robotic System Diagram

DASY5 Instrumentation Chain

The first step of the evaluation is a linearization of the filtered input signal to account for the compression characteristics of the detector diode. The compensation depends on the input signal, the diode type and the DC-transmission factor from the diode to the evaluation electronics. If the exciting field is pulsed, the crest factor of the signal must be known to correctly compensate for peak power. The formula for each channel can be given as:

$$V_i = U_i + U_i^2 \cdot \frac{cf}{dcp_i}$$

with	V_i	= compensated signal of channel i	(i = x, y, z)
	U_i	= input signal of channel i	(i = x, y, z)
	cf	= crest factor of exciting field	(DASY parameter)
	dcp_i	= diode compression point	(DASY parameter)

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From the compensated input signals the primary field data for each channel can be evaluated:

E – fieldprobes :
$$E_i = \sqrt{\frac{V_i}{Norm_i \cdot ConvF}}$$

with
$$V_i$$
 = compensated signal of channel i (i = x, y, z)
 $Norm_i$ = sensor sensitivity of channel i (i = x, y, z)
 $\mu V/(V/m)^2$ for E-field Probes
 $ConvF$ = sensitivity enhancement in solution
 E_i = electric field strength of channel i in V/m

The RSS value of the field components gives the total field strength (Hermitian magnitude):

$$E_{tot} = \sqrt{E_x^2 + E_y^2 + E_z^2}$$

The primary field data are used to calculate the derived field units.

The measurement/integration time per point, as specified by the system manufacturer is >500ms.

The signal response time is evaluated as the time required by the system to reach 90% of the expected final value after an on/off switch of the power source with an integration time of 500ms and a probe response time of <5 ms. In the current implementation, DASY5 waits longer than 100ms after having reached the grid point before starting a measurement, i.e., the response time uncertainty is negligible.

If the device under test does not emit a CW signal, the integration time applied to measure the electric field at a specific point may introduce additional uncertainties due to the discretization. The tolerances for the different systems had the worst-case of 2.6%.

Environmental Conditions

Environmental conditions such as temperature and relative humidity are monitored to ensure there are no impacts on system specifications. Proper voltage and power line frequency conditions are maintained with three phase power sources. Environmental noise and reflections are monitored through system checks.

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5. TEST PROCEDURE

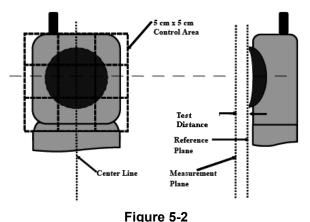
I. RF EMISSIONS

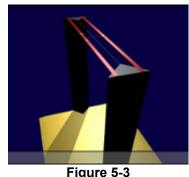
Test Instructions Confirm proper operation of ≻ probes and instrumentation Position WD \geq **Configure WD TX operation** ≻ Per 5.5.1.2 (a-c) Initialize field probe ⋟ Scan Area ≻ Per 5.5.1.2 (d-f) Identify exclusion area. \geq \geq Rescan or reanalyze open area to determine maximum Indirect method: Add the MIF ≻ to the maximum steady state rms field strength and record **RF** Audio Interference Level, in dB(V/m) Per 5.5.1.2 (g-h) & 5.5.1.3 Identify and record the ≻ category Per 5.5.1.2 (i-j)

Figure 5-1 RF Emissions Flow Chart

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Test Setup





HAC Phantom

E-Field Emissions Test Setup Diagram (See Test Photographs for actual WD scan grid overlay)

RF Emissions Test Procedure:

The following illustrate a typical RF emissions test scan over a wireless communications device:

- 1. Proper operation of the field probe, probe measurement system, other instrumentation, and the positioning system was confirmed.
- 2. WD is positioned in its intended test position, acoustic output point of the device perpendicular to the field probe.
- 3. The WD operation for maximum rated RF output power was configured and confirmed with the base station simulator, at the test channel and other normal operating parameters as intended for the test. The battery was ensured to be fully charged before each test.
- 4. The center sub-grid was centered over the center of the acoustic output (also audio band magnetic output, if applicable). The WD audio output was positioned tangent (as physically possible) to the measurement plane.
- 5. A surface calibration was performed before each setup change to ensure repeatable spacing and proper maintenance of the measurement plane using the HAC Phantom.
- 6. The measurement system measured the field strength at the reference location.
- 7. Measurements at 2mm or 5mm increments in the 5 x 5 cm region were performed at a distance 15 mm from the center point of the probe measurement element to the WD. A 360° rotation about the azimuth axis at the maximum interpolated position was measured. For the worst-case condition, the peak reading from this rotation was used in re-evaluating the HAC category.
- 8. The system performed a drift evaluation by measuring the field at the reference location. If the power drift deviated by more than 5%, the HAC test and drift measurements were repeated.

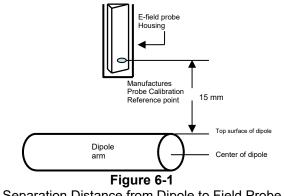
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6. SYSTEM CHECK

System Check Parameters I.

The input signal was an un-modulated continuous wave. The following points were taken into consideration in performing this check:

- Average Input Power P = 100mW RMS (20dBm RMS) after adjustment for return loss
- The test fixture must meet the 2 wavelength separation criterion •
- The proper measurement of the 15 mm probe to dipole separation, which is measured from top surface of the dipole to the calibration reference point of the sensor, defined by the probe manufacturer is shown in the following diagram:



Separation Distance from Dipole to Field Probe

RF power was recorded using both an average reading meter and a peak reading meter. Readings of the probe are provided by the measurement system.

To assure proper operation of the near-field measurement probe the input power to the dipole shall be commensurate with the full rated output power of the wireless device [e.g. - for a cellular phone wireless device the average peak antenna input power will be on the order of 100mW (20dBm) RMS] after adjustment for any mismatch.

II. Validation Procedure

A dipole antenna meeting the requirements given in C63.19 was placed in the position normally occupied by the WD.

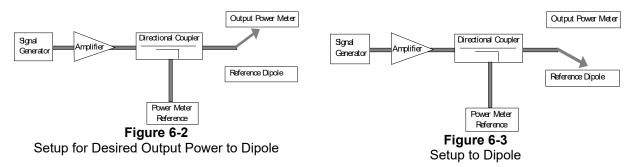
The length of the dipole was scanned, and the average peak value was recorded.

Measurement of CW

Using the near-field measurement system, scan the antenna over the radiating dipole and record the greatest field reading observed. Due to the nature of E-fields about free-space dipoles, the two E-field peaks measured over the dipole are averaged to compensate for non-parallelity of the setup (see manufacturer method on dipole calibration certificates, page 2). Field strength measurements shall be made only when the probe is stationary.

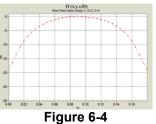
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RF power was recorded using both an average and a peak power reading meter.

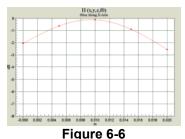


Using this setup configuration, the signal generator was adjusted for the desired output power (100mW) at a specified frequency. The reference power from the coupled port of the directional coupler is recorded. Next, the output cable is connected to the reference dipole, as shown in Figure 6-3.

The input signal level was adjusted until the reference power from the coupled port of the directional coupler was the same as previously recorded, to compensate for the impedance mismatch between the output cable and the reference dipole. To assure proper operation of the near-field measurement probe the input power to the reference dipole was verified to the full rated output power of the wireless device. The dipole was secured in a holder in a manner to meet the 20 dB reflection. The near-field measurement probe was positioned over the dipole. The antenna was scanned over the appropriate sized area to cover the dipole from end to end. SPEAG uses 2D interpolation algorithms between the measured points. Please see below two dimensional plots showing that the interpolated values interpolate smoothly between 5mm steps for a free-space RF dipole:



2-D Raw Data from scan along dipole axis



2-D Raw Data from scan along transverse axis



2-D Interpolated points from scan along dipole axis

								-	~	
	1								-	
-	-	-	-	-	-	-	-	-	-	
	-	-		-	-				-	
	-	-	-	-	-	-		_	-	

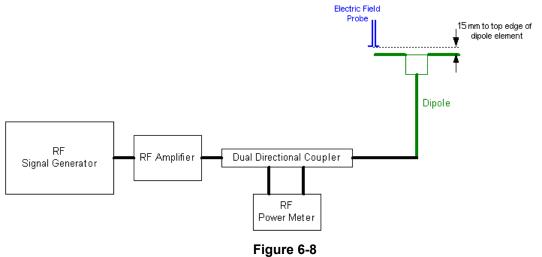
Figure 6-7 2-D Interpolated points from scan along transverse axis

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III. System Check Results

Validation Results

Date	Frequency (MHz)	Probe S/N	DAE S/N	Dipole S/N	Input Power (dBm)	E-field Result (V/m)	Target Field (V/m)	% Deviation
5/27/2019	835	4035	4445	1003	20.0	106.0	105.2	0.8%
6/3/2019	1880	4035	1415	1137	20.0	91.9	87.8	4.7%



System Check Setup

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7. MODULATION INTERFERENCE FACTOR

I. Measuring Modulation Interference Factors

For any specific fixed and repeatable modulated signal, a modulation interference factor (MIF, expressed in dB) may be determined that relates its interference potential to its steady-state RMS signal level or average power level. This factor is a function only of the audio-frequency amplitude modulation characteristics of the signal and is the same for field-strength and conducted power measurements. The MIF is valid only for a specific repeatable audio-frequency amplitude modulation characteristic; any change in modulation characteristic requires determination and application of a new MIF.

The MIF may be determined using a radiated RF field or a conducted RF signal:

- a. Using RF illumination or conducted coupling, apply the specific modulated signal in question to the measurement system at a level within its confirmed operating dynamic range.
- b. Measure the steady-state RMS level at the output of the fast probe or sensor.
- c. Measure the steady-state average level at the weighting output.
- d. Without changing the square-law detector or weighting system, and using RF illumination or conducted coupling, substitute for the specific modulated signal a 1 kHz, 80% amplitude modulated carrier at the same frequency and adjust its strength until the level at the weighting output equals the step c) measurement.
- e. Without changing the carrier level from step d), remove the 1 kHz modulation and again measure the steady-state RMS level indicated at the output of the fast probe or sensor.
- f. The MIF for the specific modulation characteristic is provided by the ratio of the step e) measurement to the step b) measurement, expressed in dB (20 × log[(step e)/(step b)]).

The following procedure was used to measure the MIF using the SPEAG Audio Interference Analyzer (AIA), Type No: SE UMS 170 CB, Serial No.: 1010:

- 1. The device was placed into a simulated call using a base station simulator or set to transmit using test software for a given mode.
- 2. The device was then set to continuously transmit at maximum power.
- 3. Using a coupler if needed, the device output signal was connected to the RF In port of the AIA, which was connected to a desktop computer. Alternatively, a radiated RF signal may be used with the AIA's built-in antenna.
- 4. The MIF measurement procedure in the DASY software was run, and the resulting MIF value was recorded.
- 5. Steps 1-4 were repeated for all CMRS air interfaces, frequency bands, and modulations.

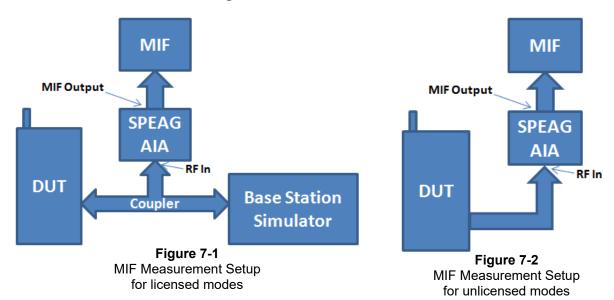
The modulation interference factors obtained were applied to readings taken of the actual wireless device in order to obtain an accurate audio interference level reading using the formula:

Audio Interference Level [dB(V/m)] = 20 * log[Raw Field Value (V/m)] + MIF (dB)

Because the MIF value is output power independent, MIF values for a given mode should be constant across all devices; however, per C63.19-2011 §D.7, MIF values should be measured for each device being evaluated. The voice modes for this device have been investigated in this section of the report.

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II. MIF Measurement Block Diagrams



III. Measured Modulation Interference Factors:

	Table 7-1										
GSM Modulation Interference Factors ¹											
	al a		GSM850			GSM1900					
Mode		128	190	251	512	661	810				
Voice		3.55	3.54	3.55	3.55	3.54	3.54				
GSM	EDGE	3.75	3.76	3.74	3.70	3.70	3.71				

 Table 7-2

 UMTS Modulation Interference Factors¹

Mode		UMTS V			UMTS IV			UMTS II		
		4132	4183	4233	1312	1412	1513	9262	9400	9538
	12.2 kbps RMC	-24.98	-25.45	-25.13	-25.05	-25.49	-25.12	-25.51	-25.40	-24.39
UMTS	12.2 kbps AMR	-25.05	-25.30	-25.00	-25.25	-25.34	-25.06	-25.37	-25.13	-24.07
	HSUPA Subtest1	-23.59	-23.84	-23.53	-24.02	-24.28	-23.85	-24.00	-23.59	-23.47

¹ Note: Measured MIF values may be lower than sample MIF values provided in ANSI C63.19-2011 Annex D.7 Table D.5 due to manufacturing variations for each device, however per Annex D.7, the sample MIF values of Table D.5 are not intended to substitute for measurements of actual devices under test and their respective operating modes.

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LTE Band	Frequency [MHz]	Channel	Bandwidth [MHz]	Modulation	RB Size	RB Offset	MIF [dB]
12	707.5	23095	10	16QAM	1	0	-9.63
14	793.0	23330	10	16QAM	1	0	-10.47
5	836.5	20525	10	16QAM	1	0	-10.02
4	1732.5	20175	20	16QAM	1	0	-9.13
2	1880.0	18900	20	16QAM	1	0	-10.13
4	1732.5	20175	20	QPSK	1	0	-14.37
4	1732.5	20175	20	16QAM	1	50	-9.11
4	1732.5	20175	20	16QAM	1	99	-9.14
4	1732.5	20175	20	16QAM	50	0	-16.07
4	1732.5	20175	20	16QAM	100	0	-17.00
4	1732.5	20175	15	16QAM	1	36	-9.91
4	1732.5	20175	10	16QAM	1	25	-9.94
4	1732.5	20175	5	16QAM	1	12	-10.23
4	1732.5	20175	3	16QAM	1	7	-10.20
4	1732.5	20175	1.4	16QAM	1	2	-9.69
4	1720.0	20050	20	16QAM	1	50	-10.27
4	1745.0	20300	20	16QAM	1	50	-9.85

 Table 7-3

 LTE FDD Modulation Interference Factors^{1,3}

 Table 7-4

 802.11b (2.4GHz, SISO) Modulation Interference Factors^{1,2}

	802.11b MIF Measurements [dB]							
Mode	Data Rate [Mbps]							
	1	2	5.5	11				
802.11b	-16.20	-15.88	-11.76	-11.89				

Table 7-5

802.11g (2.4GHz, SISO) Modulation Interference Factors^{1,2}

		802.11g MIF Measurements [dB]								
Mode		Data Rate [Mbps]								
	6	6 9 12 18 24 36 48 54								
802.11g	-14.16	-14.16 -13.61 -13.20 -12.39 -12.10 -11.57 -11.80 -12.02								

	Table 7-6 802.11n (2.4GHz, SISO) Modulation Interference Factors ^{1,2}
	802.11n (2.4GHz) MIF Measurements [dB]
Mode	Data Rate [Mbps]

Mode	Data Rate [Mbps]								
	6.5	6.5 13 19.5 26 39 52 58.5 65							
802.11n	-13.96	-12.72	-12.42	-11.98	-11.75	-11.98	-12.36	-12.47	

¹ Note: Measured MIF values may be lower than sample MIF values provided in ANSI C63.19-2011 Annex D.7 Table D.5 due to manufacturing variations for each device, however per Annex D.7, the sample MIF values of Table D.5 are not intended to substitute for measurements of actual devices under test and their respective operating modes.

² Note: WIFI MIF values were found to be independent of the transmit channel.

³ Note: All FDD LTE bands were found to have substantially similar MIF values given similar RB, BW, and modulation configurations.

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8. RF CONDUCTED POWER MEASUREMENTS

I. Procedures Used to Establish RF Signal for HAC Testing

The handset was placed into a simulated call using a base station simulator in a shielded chamber. Such test signals offer a consistent means for testing HAC and are recommended for evaluating HAC. Measurements were taken with a fully charged battery. In order to verify that the device was tested and maintained at full power, this was configured with the base station simulator.

II. HAC Measurement Conditions

Output Power Verification

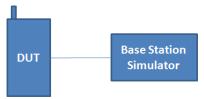
Maximum output power is verified on the High, Middle and Low channels for all applicable air interfaces. See Table 8-1 for air interface specific settings of transmit power parameters.

Power Control Parameters and Settings by Air Interface							
Air Interface: Parameter Name: Parameter Set To:							
GSM	PCL	GSM850: "5"; GSM1900: "0"					
UMTS	TPC	"All 1's"					
LTE	"Max Power"						
WIFI	Mfr Configured	Mfr Specified					

Table 8-1

III. Setup Used to Measure RF Conducted Powers

Power measurements for licensed modes were performed using a base station simulator under digital average power. Power measurements for unlicensed modes were performed using a power meter and power sensor.



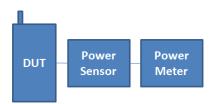
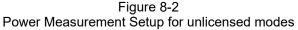


Figure 8-1 Power Measurement Setup for licensed modes



IV. GSM Conducted Powers

Band	Channel	GSM [dBm] CS (1 Slot)	EDGE [dBm] 1 Tx Slot
	128	32.15	26.17
GSM 850	190	32.16	26.05
	251	32.10	26.08
	512	28.91	25.10
GSM 1900	661	28.68	24.94
	810	28.58	24.95

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V. UMTS Conducted Powers

3GPP Release	Mode	3GPP 34.121 Subtest	Cellu	lar Band [dBm]	AW	S Band [d	Bm]	PCS	PCS Band [dBm]		
Version	rsion	Subtest	4132	4183	4233	1312	1412	1513	9262	9400	9538	
99	WCDMA	12.2 kbps RMC	25.22	25.26	25.18	24.72	24.65	24.55	24.67	24.64	24.78	
99	W CDINK	12.2 kbps AMR	25.16	25.21	25.20	24.67	24.63	24.53	24.65	24.70	24.77	
6	HSUPA	Subtest 1	24.51	24.48	24.46	23.54	23.37	23.44	23.30	23.45	23.48	

VI. LTE Conducted Powers

a. LTE Band 12

14					
			Table 8-2		
F Band	12 (707	5MHz)	Conducted P	owers – 10M	IHz Bandwi
una	(101		LTE Band 12		
			10 MHz Bandwidth		
			Mid Channel		
Modulation	RB Size	RB Offset	23095 (707.5 MHz)	MPR Allowed per 3GPP [dB]	MPR [dB]
			Conducted Power		
			[dBm]		
	1	0	25.28		0
	1	25	25.24	0	0
	1	49	25.19		0
QPSK	25	0	24.01		1
	25	12	23.95		1
	25	25	23.90	0-1	1
	50	0	23.98		1
	1	0	23.54		1
	1	25	23.49	0-1	1
	1	49	23.50	1	1
16QAM	25	0	22.93		2
	25	12	22.90	1	2
	25	25	22.88	0-2	2
	50	0	23.05	1	2

Note: Since LTE Band 12 at 10MHz bandwidth does not support 3 non-overlapping channels, conducted power measurements were made only on the middle channel.

	Table 8-3
LTE Band 12 (707.5MHz) Conducted Powers – 5MHz Bandwidth

				LTE Band 12			
			Low Channel	5 MHz Bandwidth Mid Channel	High Channel		
Modulation	RB Size	RB Offset	23035 (701.5 MHz)	23095 (707.5 MHz)	23155 (713.5 MHz)	MPR Allowed per 3GPP [dB]	MPR [dB]
				Conducted Power [dBm]		
	1	0	25.04	24.95	24.88		0
	1	12	24.98	25.25	25.03	0	0
	1	24	25.07	25.08	25.02		0
QPSK	12	0	23.80	23.75	23.71		1
	12	6	23.80	23.77	23.77	0-1	1
	12	13	23.69	23.75	23.74	0-1	1
	25	0	23.76	23.78	23.70		1
	1	0	23.22	23.32	23.54		1
	1	12	23.72	23.53	23.47	0-1	1
	1	24	23.49	23.36	23.07		1
16QAM	12	0	22.64	22.61	22.68		2
	12	6	22.68	22.65	22.66	0-2	2
	12	13	22.61	22.59	22.84	0-2	2
	25	0	22.72	22.68	22.78		2

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			2 (101.300112)	Conducted P	0 wei $3 = 5$ m		
				LTE Band 12			
				3 MHz Bandwidth	r	1	
			Low Channel	Mid Channel	High Channel		
Modulation	RB Size	RB Offset	23025	23095	23165	MPR Allowed per	MPR [dB]
Wouldtion	KD Size	KB Oliset	(700.5 MHz)	(707.5 MHz)	(714.5 MHz)	3GPP [dB]	WER [UD]
			(Conducted Power [dBm]		
	1	0	24.72	24.54	24.18		0
	1	7	24.98	24.52	24.44	0	0
	1	14	24.66	24.51	24.21		0
QPSK	8	0	23.70	23.53	23.38		1
	8	4	23.69	23.58	23.46	0-1	1
	8	7	23.63	23.59	23.42	0-1	1
	15	0	23.67	23.56	23.45		1
	1	0	23.50	23.11	22.96		1
	1	7	23.37	23.12	23.05	0-1	1
	1	14	23.18	23.16	22.91		1
16QAM	8	0	22.54	22.45	22.40		2
	8	4	22.60	22.52	22.20	0-2	2
	8	7	22.53	22.51	22.30	0-2	2
	15	0	22.77	22.57	22.60		2

Table 8-4 LTE Band 12 (707.5MHz) Conducted Powers – 3MHz Bandwidth

Table 8-5

LTE Band 12 (707.5MHz) Conducted Powers – 1.4MHz Bandwidth

				LTE Band 12 1.4 MHz Bandwidth			
			Low Channel	Mid Channel	High Channel		
Modulation	RB Size	RB Offset	23017 (699.7 MHz)	23095 (707.5 MHz)	23173 (715.3 MHz)	MPR Allowed per 3GPP [dB]	MPR [dB]
				Conducted Power [dBm]		
	1	0	24.31	24.31	24.23		0
	1	2	24.26	23.94	24.23		0
	1	5	24.22	24.15	24.22		0
QPSK	3	0	23.87	23.97	23.89	- 0	0
	3	2	24.04	23.87	23.66]	0
	3	3	23.80	23.87	23.67]	0
	6	0	23.56	23.63	23.56	0-1	1
	1	0	23.44	23.72	23.65		1
	1	2	23.60	23.32	23.46	1	1
	1	5	23.68	23.67	23.60	0-1	1
16QAM	3	0	23.55	23.54	23.65	0-1	1
	3	2	23.71	23.52	23.57]	1
	3	3	23.53	23.68	23.65		1
	6	0	22.65	22.55	22.59	0-2	2

b. LTE Band 14

			LTE Band 14 10 MHz Bandwidth		
Modulation RB Size	RB Size	RB Offset	Mid Channel 23330 (793.0 MHz)	MPR Allowed per	MPR [dB]
			Conducted Power [dBm]	3GPP [dB]	
	1	0	25.30		0
	1	25	25.27	0	0
	1	49	25.21		0
QPSK	25	0	23.64		1
	25	12	23.53	0-1	1
	25	25	23.72	0-1	1
	50	0	23.62	Γ	1
	1	0	23.48		1
	1	25	23.38	0-1	1
	1	49	23.41		1
16QAM	25	0	22.48		2
	25	12	22.68	0-2	2
	25	25	22.37	0-2	2
	50	0	22.45	Ē	2

	Table 8-6
LTE Band 14 (793.0MHz) C	Conducted Powers – 10MHz Bandwidth

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Band 1	14 (793.	<u>UMHZ)</u>	Conducted	Powers – 51	VIHZ Ban
			LTE Band 14 5 MHz Bandwidth		
			Mid Channel		
Modulation	RB Size	RB Offset	23330 (793.0 MHz)	MPR Allowed per 3GPP [dB]	MPR [dB]
			Conducted Power [dBm]		
	1	0	25.16		0
	1	12	25.30	0	0
	1	24	25.09		0
QPSK	12	0	23.81		1
	12	6	23.56	0-1	1
	12	13	23.41	0-1	1
	25	0	23.43		1
	1	0	23.48		1
	1	12	23.42	0-1	1
	1	24	23.44		1
16QAM	12	0	22.46		2
	12	6	22.55	0-2	2
	12	13	22.52	0-2	2
	25	0	22.61	Ī	2

 Table 8-7

 LTE Band 14 (793.0MHz) Conducted Powers – 5MHz Bandwidth

Note: Since LTE Band 14 at 5MHz bandwidth does not support 3 non-overlapping channels, conducted power measurements were made only on the middle channel.

c. LTE Band 5

	Table 8-8								
LT	LTE Band 5 (836.5MHz) Conducted Powers - 10MHz Bandwidth								

Modulation	RB Size	RB Offset	Mid Channel 20525 (836.5 MHz)	MPR Allowed per 3GPP [dB]	MPR [dB]
			Conducted Power [dBm]		
	1	0	25.30		0
	1	25	25.23	0	0
	1	49	25.28		0
QPSK	25	0	24.02		1
	25	12	23.95		1
	25	25	23.94		1
	50	0	24.00		1
	1	0	23.63		1
	1	25	23.54	0-1	1
	1	49	23.34		1
16QAM	25	0	23.04		2
	25	12	23.02	0-2	2
	25	25	22.89	0-2	2
	50	0	22.97		2

Note: Since LTE Band 5 at 10MHz bandwidth does not support 3 non-overlapping channels, conducted power measurements were made only on the middle channel.

Table 8-9 LTE Band 5 (836.5MHz) Conducted Powers – 5MHz Bandwidth									
LTE Band 5 (Cell) 5 MHz Bandwidth									
Modulation	RB Size	RB Offset	20425 (826.5 MHz)	20525 (836.5 MHz)	20625 (846.5 MHz)	MPR Allowed per 3GPP [dB]	MPR [dB]		
			(Conducted Power [dBm]				
	1	0	25.21	25.12	24.85		0		
	1	12	25.26	25.30	25.17	0	0		
	1	24	25.20	25.29	25.18		0		
QPSK	12	0	23.98	24.08	23.80	0-1	1		
	12	6	23.88	23.99	23.93		1		
	12	13	23.84	23.95	23.82	0-1	1		
	25	0	23.91	23.98	23.84		1		
	1	0	23.40	23.37	23.30		1		
	1	12	23.55	23.45	23.39	0-1	1		
	1	24	23.45	23.34	23.26		1		
16QAM	12	0	22.63	22.58	22.77		2		
	12	6	22.72	22.95	22.80	0-2	2		
	12	13	22.73	22.81	22.70	0-2	2		
	25	0	22.78	22.91	22.80		2		

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		Dana C	(000101112)	oonaucteur	enere en	E Banamat	•
				LTE Band 5 (Cell)			
		1		3 MHz Bandwidth			
			Low Channel	Mid Channel	High Channel	_	
Modulation	RB Size	RB Offset	20415 (825.5 MHz)	20525 (836.5 MHz)	20635 (847.5 MHz)	MPR Allowed per 3GPP [dB]	MPR [dB]
			(Conducted Power [dBm]		
	1	0	25.27	25.14	25.11	0	0
	1	7	25.28	25.29	25.13		0
	1	14	25.13	25.28	25.01		0
QPSK	8	0	24.01	24.02	23.94	- 0-1	1
	8	4	23.88	24.04	23.89		1
	8	7	23.82	23.90	23.93		1
	15	0	23.85	24.01	23.95		1
	1	0	23.40	23.36	23.50		1
	1	7	23.47	23.45	23.37	0-1	1
	1	14	23.48	23.45	23.32		1
16QAM	8	0	22.78	22.66	22.88		2
	8	4	22.89	22.61	22.98	0-2	2
	8	7	22.85	22.98	22.97	0-2	2
	15	0	22.83	22.96	22.87		2

Table 8-10 LTE Band 5 (836.5MHz) Conducted Powers – 3MHz Bandwidth

Table 8-11 LTE Band 5 (836.5MHz) Conducted Powers - 1.4MHz Bandwidth

	LTE Band 5 (Cell) 1.4 MHz Bandwidth										
			Low Channel	Mid Channel	High Channel	_					
Modulation	RB Size	RB Offset	20407 (824.7 MHz)	20525 (836.5 MHz)	20643 (848.3 MHz)	MPR Allowed per 3GPP [dB]	MPR [dB]				
				Conducted Power [dBm]						
	1	0	25.27	25.18	25.15		0				
	1	2	25.26	25.21	25.22	0	0				
	1	5	25.20	25.15	25.23		0				
QPSK	3	0	25.11	25.08	25.05		0				
	3	2	25.21	25.13	25.22		0				
	3	3	25.12	24.78	25.19		0				
	6	0	23.96	23.99	23.95	0-1	1				
	1	0	23.39	23.48	23.55		1				
	1	2	23.40	23.45	23.46		1				
	1	5	23.38	23.57	23.44	0.1	1				
16QAM	3	0	23.93	23.85	23.95	- 0-1	1				
	3	2	23.90	24.04	23.88		1				
	3	3	23.73	23.95	23.87		1				
	6	0	22.78	22.89	22.91	0-2	2				

d. LTE Band 4

Table 8-12 LTE Band 4 (1732.5MHz) Conducted Powers – 20MHz Bandwidth

			Mid Channel			
Modulation	RB Size	RB Offset	20175 (1732.5 MHz)	MPR Allowed per 3GPP [dB]	MPR [dB]	
			Conducted Power [dBm]	JOFF [UB]		
	1	0	24.72		0	
	1	50	24.78	0	0	
[1	99	24.79		0	
QPSK	50	0	23.17		1	
	50	25	23.13	0-1	1	
	50	50	23.18		1	
	100	0	23.16		1	
	1	0	23.26		1	
	1	50	23.29	0-1	1	
[1	99	23.08		1	
16QAM	50	0	22.34		2	
[50	25	22.38	0-2	2	
	50	50	22.32	0-2	2	
ſ	100	0	22.30		2	

Note: Since LTE Band 4 at 20MHz bandwidth does not support 3 non-overlapping channels, conducted power measurements were made only on the middle channel.

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				LTE Band 4 (AWS) 15 MHz Bandwidth				
Modulation	RB Size	RB Size	RB Offset	Low Channel 20025 (1717.5 MHz)	Mid Channel 20175 (1732.5 MHz)	High Channel 20325 (1747.5 MHz)	MPR Allowed per 3GPP [dB]	MPR [dB]
				Conducted Power [dBm]			
	1	0	24.58	24.78	24.62		0	
	1	36	24.77	24.70	24.80	0	0	
	1	74	24.80	24.79	24.79] [0	
QPSK	36	0	23.21	23.07	23.18		1	
[36	18	23.13	23.07	23.19	0-1	1	
	36	37	23.11	23.08	23.09		1	
	75	0	23.08	23.07	23.12		1	
	1	0	23.61	23.29	23.16		1	
	1	36	23.80	23.15	23.44	0-1	1	
[1	74	23.25	23.05	23.01		1	
16QAM	36	0	22.34	22.16	22.21		2	
[36	18	22.39	22.26	22.23	0.2	2	
[36	37	22.24	22.18	22.23	0-2	2	
	75	0	22.22	22.18	22.18		2	

 Table 8-13

 LTE Band 4 (1732.5MHz) Conducted Powers – 15MHz Bandwidth

Table 8-14

LTE Band 4 (1732.5MHz) Conducted Powers – 10MHz Bandwidth

				LTE Band 4 (AWS)											
Modulation	RB Size	RB Offset	Low Channel 20000 (1715.0 MHz)	10 MHz Bandwidth Mid Channel 20175 (1732.5 MHz)	High Channel 20350 (1750.0 MHz)	MPR Allowed per 3GPP [dB]	MPR [dB]								
				Conducted Power [dBm]											
	1	0	24.22	24.69	24.54		0								
	1	25	24.50	24.68	24.58	0	0								
	1	49	24.45	24.56	24.60		0								
QPSK	25	0	23.14	23.04	23.11	- 0-1	1								
	25	12	23.20	23.15	23.14		1								
	25	25	23.08	23.18	23.04		1								
	50	0	23.18	23.12	23.12		1								
	1	0	22.87	23.19	23.32		1								
	1	25	23.33	23.13	23.21	0-1	1								
	1	49	22.97	22.86	23.07		1								
16QAM	25	0	22.29	22.17	22.30	0-2	2								
	25	12	22.27	22.27	22.37		2								
	25	25	22.14	22.40	22.16		2								
	50	0	22.18	22.12	22.23		2								

Table 8-15 LTE Band 4 (1732.5MHz) Conducted Powers – 5MHz Bandwidth

				LTE Band 4 (AWS) 5 MHz Bandwidth			
			Low Channel	Mid Channel	High Channel		
Modulation	RB Size	RB Offset	19975 (1712.5 MHz)	20175 (1732.5 MHz)	20375 (1752.5 MHz)	MPR Allowed per 3GPP [dB]	MPR [dB]
			(Conducted Power [dBm]		
	1	0	24.21	24.17	24.49	0	0
	1	12	24.54	24.38	24.73		0
	1	24	24.46	24.34	24.45		0
QPSK	12	0	23.10	23.00	23.17	- 0-1	1
	12	6	23.12	23.04	23.23		1
	12	13	23.05	23.08	23.12		1
	25	0	22.95	23.00	23.18		1
	1	0	22.88	22.94	23.28		1
	1	12	22.84	23.41	23.38	0-1	1
	1	24	22.79	23.19	23.42		1
16QAM	12	0	22.26	22.23	22.33		2
	12	6	22.25	22.28	22.39	0-2	2
	12	13	22.21	22.23	22.27		2
	25	0	22.21	22.12	22.22		2

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	LIC	E Danu 4		Conducted P	owers – Sivir	iz banuwiuth		
				LTE Band 4 (AWS) 3 MHz Bandwidth				
Modulation	RB Size	RB Size	RB Offset	Low Channel 19965 (1711.5 MHz)	Mid Channel 20175 (1732.5 MHz)	High Channel 20385 (1753.5 MHz)	MPR Allowed per 3GPP [dB]	MPR [dB]
			Conducted Power [dBm]					
	1	0	24.51	24.38	24.46		0	
	1	7	24.58	24.53	24.75	0	0	
	1	14	24.44	24.48	24.55		0	
QPSK	8	0	23.13	22.99	23.05	0-1	1	
	8	4	23.10	23.03	22.99		1	
	8	7	22.97	23.09	23.15		1	
	15	0	23.06	23.10	23.08		1	
	1	0	22.93	23.01	22.86		1	
	1	7	23.00	23.26	22.93	0-1	1	
	1	14	22.98	23.18	23.00		1	
16QAM	8	0	21.99	21.97	21.97		2	
	8	4	21.95	22.12	22.11	0.2	2	
	8	7	21.85	22.17	21.98	0-2	2	
-	15	0	22.03	22.09	21.95		2	

 Table 8-16

 LTE Band 4 (1732.5MHz) Conducted Powers – 3MHz Bandwidth

Table 8-17

LTE Band 4 (1732.5MHz) Conducted Powers – 1.4MHz Bandwidth

		1	1.4 MHz Bandwidth								
			Low Channel	Mid Channel	High Channel	4 1					
Modulation	RB Size	RB Offset	t 19957	20175	20393	MPR Allowed per 3GPP [dB]	MPR [dB]				
			(1710.7 MHz)	(1732.5 MHz)	(1754.3 MHz)						
				Conducted Power [dBm]							
QPSK	1	0	24.50	24.48	24.79		0				
	1	2	24.55	24.59	24.80		0				
	1	5	24.53	24.63	24.76	0	0				
	3	0	24.58	24.62	24.80	U	0				
	3	2	24.67	24.59	24.76	-	0				
	3	3	24.64	24.52	24.79		0				
	6	0	23.06	22.99	23.15	0-1	1				
	1	0	22.88	22.96	22.87		1				
	1	2	22.70	23.00	22.81	1	1				
	1	5	22.80	23.04	22.82	0-1	1				
16QAM	3	0	23.45	22.69	22.87	0-1	1				
	3	2	23.30	22.75	22.87	1	1				
	3	3	23.16	23.05	22.84] [1				
	6	0	22.04	22.10	22.35	0-2	2				

e. LTE Band 2

 Table 8-18

 LTE Band 2 (1880.0MHz) Conducted Powers – 20MHz Bandwidth

	LTE Band 2 (PCS) 20 MHz Bandwidth								
		Size RB Offset	Low Channel	Mid Channel	High Channel				
Modulation	RB Size		18700 (1860.0 MHz)	18900 (1880.0 MHz)	19100 (1900.0 MHz)	MPR Allowed per 3GPP [dB]	MPR [dB]		
			Conducted Power [dBm]						
QPSK	1	0	24.79	24.62	24.79	0	0		
	1	50	24.75	24.74	24.80		0		
	1	99	24.73	24.64	24.72		0		
	50	0	23.19	23.20	23.24	0-1	1		
	50	25	23.15	23.23	23.22		1		
	50	50	23.06	23.07	23.19		1		
	100	0	23.14	23.13	23.18		1		
	1	0	23.14	22.76	22.90		1		
	1	50	22.96	22.93	22.87	0-1	1		
	1	99	22.84	22.98	22.81		1		
16QAM	50	0	22.13	22.22	22.18		2		
	50	25	22.21	22.25	22.17	0-2	2		
	50	50	22.15	22.11	22.14	0-2	2		
	100	0	22.25	22.13	22.28		2		

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LIE Band 2 (1880.0MHZ) Conducted Powers – 15MHZ Bandwidth										
	LTE Band 2 (PCS)									
		1		15 MHz Bandwidth						
Modulation			Low Channel	Mid Channel	High Channel					
	RB Size	RB Offset	18675	18900	19125	MPR Allowed per	MPR [dB]			
	ITE OILC	TED ONSOL	(1857.5 MHz) (1880.0 MHz) (1902.5 MHz)	3GPP [dB]	in referri					
			Conducted Power [dBm]							
	1	0	24.41	24.61	24.71	0	0			
	1	36	24.73	24.69	24.76		0			
	1	74	24.49	24.70	24.54		0			
QPSK	36	0	23.20	23.15	23.29		1			
	36	18	23.05	23.14	23.38	0-1	1			
	36	37	22.96	23.00	23.29	0-1	1			
	75	0	22.95	22.95	23.29		1			
	1	0	22.92	22.87	23.09		1			
	1	36	23.29	23.39	22.84	0-1	1			
	1	74	22.76	22.80	22.97		1			
16QAM	36	0	22.15	22.33	22.34		2			
	36	18	22.22	22.35	22.36	0-2	2			
	36	37	22.15	22.22	22.37	0-2	2			
ľ	75	0	22.15	22.15	22.29		2			

Table 8-19 LTE Band 2 (1880 0MHz) Conducted Powers – 15MHz Bandwidth

Table 8-20 LTE Band 2 (1880.0MHz) Conducted Powers – 10MHz Bandwidth

	LTE Band 2 (PCS) 10 MHz Bandwidth									
Modulation	RB Size	RB Offset	Low Channel 18650 (1855.0 MHz)	Mid Channel 18900 (1880.0 MHz)	High Channel 19150 (1905.0 MHz)	MPR Allowed per 3GPP [dB]	MPR [dB]			
			Conducted Power [dBm]							
	1	0	24.68	24.60	24.75		0			
	1	25	24.63	24.73	24.71	0	0			
	1	49	24.43	24.75	24.45		0			
QPSK	25	0	23.01	23.20	23.28	0-1	1			
	25	12	23.18	23.28	23.17		1			
	25	25	22.95	23.15	23.25		1			
	50	0	23.13	23.18	23.00		1			
	1	0	23.01	23.04	23.50		1			
	1	25	23.44	23.13	23.21	0-1	1			
	1	49	23.06	22.90	23.16		1			
16QAM	25	0	22.23	22.23	22.41		2			
	25	12	22.30	22.19	22.35	0-2	2			
	25	25	22.07	22.08	22.13	0-2	2			
	50	0	22.01	22.01	22.08		2			

Table 8-21 LTE Band 2 (1880.0MHz) Conducted Powers – 5MHz Bandwidth

				LTE Band 2 (PCS) 5 MHz Bandwidth			
Modulation	RB Size	RB Offset	Low Channel 18625 (1852.5 MHz)	Mid Channel 18900 (1880.0 MHz)	High Channel 19175 (1907.5 MHz)	MPR Allowed per 3GPP [dB]	MPR [dB]
			Conducted Power [dBm]				
	1	0	24.50	24.33	24.54		0
	1	12	24.80	24.50	24.61	0	0
	1	24	24.55	24.33	24.59		0
QPSK	12	0	23.16	23.09	23.17		1
-	12	6	23.20	23.12	23.16	0-1	1
	12	13	23.17	23.14	23.00	0-1	1
	25	0	23.14	23.20	23.18		1
	1	0	22.98	22.87	23.63	0-1	1
	1	12	23.20	23.24	23.39		1
	1	24	22.99	23.08	23.46		1
16QAM	12	0	22.10	21.95	22.10		2
	12	6	22.24	21.96	22.04	0-2	2
	12	13	22.19	21.87	21.93	0-2	2
	25	0	22.17	22.14	22.09		2
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	LTE Band 2 (PCS) 3 MHz Bandwidth								
			Low Channel	Mid Channel	High Channel				
Modulation	RB Size	RB Offset	18615 (1851.5 MHz)	18900 (1880.0 MHz)	19185 (1908.5 MHz)	MPR Allowed per 3GPP [dB]	MPR [dB]		
			Conducted Power [dBm]						
	1	0	24.55	24.36	24.67	0	0		
	1	7	24.52	24.40	24.66		0		
	1	14	24.45	24.35	24.66		0		
QPSK	8	0	23.18	23.20	23.11	0-1	1		
	8	4	23.20	23.23	23.12		1		
	8	7	23.15	23.18	23.20		1		
	15	0	23.17	23.21	23.12		1		
	1	0	22.84	23.13	22.98		1		
	1	7	22.88	23.15	23.35	0-1	1		
	1	14	22.92	23.04	23.14		1		
16QAM	8	0	22.15	22.04	22.08		2		
	8	4	22.10	22.06	21.99	0-2	2		
	8	7	22.24	22.00	22.04	0-2	2		
	15	0	22.26	22.16	22.10		2		

Table 8-22 LTE Band 2 (1880.0MHz) Conducted Powers – 3MHz Bandwidth

Table 8-23 LTE Band 2 (1880.0MHz) Conducted Powers – 1.4MHz Bandwidth

				LTE Band 2 (PCS) 1.4 MHz Bandwidth			
Modulation	RB Size	RB Offset	Low Channel 18607 (1850.7 MHz)	Mid Channel 18900 (1880.0 MHz)	High Channel 19193 (1909.3 MHz)	MPR Allowed per 3GPP [dB]	MPR [dB]
				Conducted Power [dBm			
	1	0	24.58	24.80	24.73		0
	1	2	24.80	24.79	24.80		0
QPSK	1	5	24.77	24.79	24.76	0	0
	3	0	24.59	24.74	24.68		0
	3	2	24.65	24.80	24.78		0
	3	3	24.71	24.76	24.66		0
	6	0	23.05	23.26	23.10	0-1	1
	1	0	22.99	23.20	23.00		1
	1	2	22.94	23.24	22.84		1
	1	5	22.94	23.22	23.23	0-1	1
16QAM	3	0	23.28	22.90	23.31	1	1
	3	2	23.32	22.92	23.31		1
	3	3	23.26	22.89	23.23		1
F	6	0	21.92	22.37	21.94	0-2	2

WIFI Conducted Powers (SISO) VII.

Table 8-24 IEEE 802.11b/g/n (2.4GHz, SISO) Average RF Power

2.4GHz Conducted Power [dBm]							
Freq [MHz]	Channel	IEEE Transmission Mode					
	Channel	802.11b	802.11g	802.11n			
2412	1	15.95	14.74	13.52			
2437	6	15.96	14.61	13.57			
2462	11 15.98 10.58 9.69						

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9. JUSTIFICATION OF HELD TO EAR MODES TESTED

I. Analysis of RF Air Interface Technologies

An analysis was performed, following the guidance of §4.3 and §4.4 of the ANSI standard, of the RF air interface technologies being evaluated. The factors that will affect the RF interference potential were evaluated, and the worst-case operating modes were identified and used in the evaluation. A WD's interference potential is a function both of the WD's average near-field field strength and of the signal's audio-frequency amplitude modulation characteristics. Per §4.4, RF air interface technologies that have low power have been found to produce sufficiently low RF interference potential, so it is possible to exempt them from the product testing specified in Clause 5 of the ANSI standard. An RF air interface technology of a device is exempt from testing when its average antenna input power plus its MIF is ≤17dBm for all of its operating modes. RF air interface technologies exempted from testing in this manner are automatically assigned an M4 rating to be used in determining the overall rating for the WD.

The worst-case MIF plus the worst-case average antenna input power for all modes are investigated below to determine the testing requirements for this device.

	Max Power + MIF calculations for Low Power Exemptions								
Air Interface	Maximum Average Power (dBm)	Worst Case MIF (dB)	Total (Power + MIF, dB)	C63.19 Testing Required					
GSM850	23.13*	3.55	26.68	Yes					
GSM1900	19.88*	3.55	23.43	Yes					
EDGE850	17.14*	3.76	20.90	Yes**					
EDGE1900	16.07*	3.71	19.78	Yes**					
UMTS - RMC	25.26	-24.39	0.87	No					
UMTS - AMR	25.21	-24.07	1.14	No					
HSPA	24.51	-23.47	1.04	No					
LTE - FDD	25.30	-9.11	16.19	No					
2.4GHz WIFI	15.98	-11.57	4.41	No					

Tahlo 9-1

II. Individual Mode Evaluations

* Note: ANSI C63.19-2011 Sec. 4.4 Footnote 20 indicates the use of a long averaging time for measuring the antenna input power when using this method of exclusion. Therefore, the frame averaged power was calculated for these modes in this investigation.

** Note: EDGE data modes were considered but not tested as GSM voice modes were found to be the worst-case modes for the GSM air interface.

III. Low-Power Exemption Conclusions

Per ANSI C63.19-2011, RF Emissions testing for this device is required only for GSM voice modes. All other air interfaces are exempt.

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10. OVERALL MEASUREMENT SUMMARY

FCC ID:	ZNFX320APM
S/N:	02105

I. E-FIELD EMISSIONS:

	HAC Data Summary for E-field										
Mode	Channel	Scan Center	Conducted Power at BS (dBm)	Time Avg. Field (V/m)	Time Avg. Field [dB(V/m)]	MIF (dB)	Audio Interference Level [dB(V/m)]	FCC Limit (dBV/m)	FCC Margin (dB)	Result	Excl Blocks per 5.5
E-Field Emissio	ons										
	128	Acoustic	32.15	39.83	32.00	3.55	35.55	45.00	-9.45	M4	none
GSM850	190	Acoustic	32.16	36.02	31.13	3.54	34.67	45.00	-10.33	M4	none
	251	Acoustic	32.10	34.16	30.67	3.55	34.22	45.00	-10.78	M4	none
	512	Acoustic	28.91	23.33	27.36	3.55	30.91	35.00	-4.09	M3	none
GSM1900	661	Acoustic	28.68	20.28	26.14	3.54	29.68	35.00	-5.32	M4	none
G3W1900	810	Acoustic	28.58	22.79	27.15	3.54	30.69	35.00	-4.31	M3	none
	512	T-Coil	28.91	23.33	27.36	3.55	30.91	35.00	-4.09	M3	none



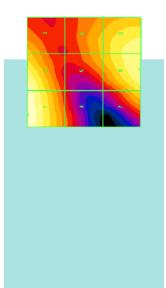


Figure 10-1 Sample E-field Scan Overlay (See Test Setup Photographs for actual WD overlay)

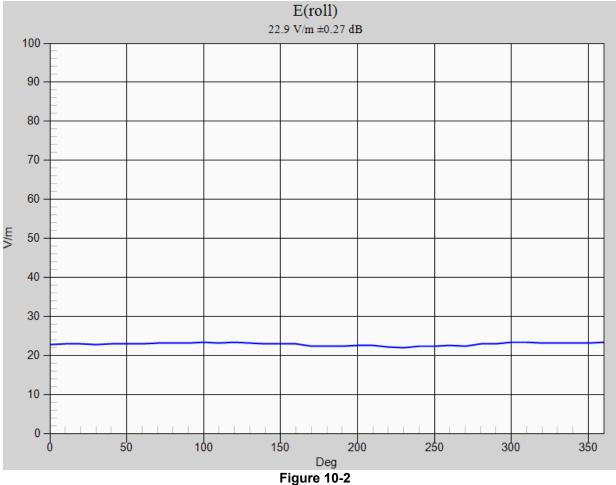
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II. Worst-case Configuration Evaluation

	Peak Reading 360° Probe Rotation at Azimuth axis									
Mode	Channel	Scan Center	Time Avg. Field (V/m)	Time Avg. Field [dB(V/m)]	MIF (dB)	Audio Interference Level [dB(V/m)]	FCC Limit (dBV/m)	FCC Margin (dB)	Result	Excl Blocks per 5.5
Probe Rotation	Probe Rotation at Worst-Case									
GSM1900	512	Acoustic	23.41	27.39	3.55	30.94	35.00	-4.06	M3	none

Table 10-2



Worst-Case Probe Rotation about Azimuth axis

* Note: Locations of probe rotation (with and without exclusions) are shown in Figure 10-1 denoted by the green square markers.

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11. EQUIPMENT LIST

Equipment List Manufacturer Model Description Cal Date Cal Interval Cal Due Serial Number GB42230325 Agilent E5515C 8960 Series 10 Wireless Communications Test Set 12/18/2018 Annual 12/18/2019 N5182A MXG Vector Signal Generator 11/28/2018 Annual 11/28/2019 MY47420603 Agilent Agilent E4438C ESG Vector Signal Generator 3/11/2019 Biennial 3/11/2021 MY45090700 Amplifier Research 15S1G6 CBT* 433978 Amplifier N/A N/A 10/21/2018 10/21/2019 1138001 Anritsu ML2496A Power Meter Annual Anritsu MA2411B Pulse Power Sensor 11/20/2018 Annual 11/20/2019 1339007 MA2411B 11/20/2018 11/20/2019 1339008 Anritsu Pulse Power Sensor Annual Anritsu MA24106A USB Power Sensor 1/31/2019 1/31/2020 1520503 Annual MA24106A Anritsu USB Power Sensor 1/31/2019 1/31/2020 1520501 Annual 2/28/2020 **Control Company** 4040 Temperature / Humidity Monitor 2/28/2018 **Biennial** 150761911 **Mini-Circuits** NLP-1200+ Low Pass Filter DC to 1000 MHz CBT* N/A N/A N/A **Mini-Circuits** NLP-2950+ Low Pass Filter DC to 2700 MHz N/A CBT* N/A N/A Mini-Circuits BW-N20W5 CBT* 1226 **Power Attenuator** N/A N/A CBT* PE2237-20 **Bidirectional Coupler** N/A N/A N/A Pasternack Rohde & Schwarz CMW500 Radio Communication tester 8/3/2018 Annual 8/3/2019 140144 1/30/2019 1/30/2020 Rohde & Schwarz CMW500 Wideband Radio Communication Tester Annual 162125 Seekonk NC-100 Torque Wrench (8" lb) 5/23/2018 Biennial 5/23/2020 N/A CBT* SPEAG AIA N/A N/A 1010 Audio Interference Analzyer SPEAG EF3DV3 Freespace E-field Probe 1/16/2019 Annual 1/16/2020 4035 SPEAG DAE4 **Dasy Data Acquisition Electronics** 3/13/2019 Annual 3/13/2020 1415 SPEAG CD835V3 Freespace 835 MHz Dipole 2/19/2019 Biennial 2/19/2021 1003 SPEAG CD1880V3 Freespace 1880 MHz Dipole 2/19/2019 2/19/2021 1137 Biennial

Table 11-1

Calibration traceable to the National Institute of Standards and Technology (NIST).

*Note: CBT (Calibrated Before Testing). Prior to testing, the measurement paths containing a cable, attenuator, coupler or filter were connected to a calibrated source (i.e. a signal generator) to determine the losses of the measurement path. The power meter offset was then adjusted to compensate for the measurement system losses. This level offset is stored within the power meter before measurements are made. This calibration verification procedure applies to the system verification and output power measurements. The calibrated reading is then taken directly from the power meter after compensation of the losses for all final power measurements.

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2/1/2019

12. MEASUREMENT UNCERTAINTY

Table 12-1

Uncertainty Estimation Table

Wireless Communications Device Near-Field Measurement Uncertainty Estimation							
Uncertainty Component	Data (dB)	Data Type	Prob. Dist.	Divisor	Ci (E)	Unc. (dB)	Notes/Comments
Measurement System							
RF System Reflections	0.50	Tolerance	Ν	1.00	1	0.50	* Refl. < -20 dB
Field Probe Calibration	0.21	Tolerance	Ν	1.00	1	0.21	
Field Probe Isotropy	0.01	Tolerance	Ν	1.00	1	0.01	
Field Probe Frequency Response	0.135	Tolerance	Ν	1.00	1	0.14	
Field Probe Linearity	0.013	Tolerance	Ν	1.00	1	0.01	
Modulation Interference Factor	0.20	Tolerance	R	1.73	1	0.12	Applicable for M-rating testing
Boundary Effects	0.105	Accuracy	R	1.73	1	0.06	*
Probe Positioning Accuracy	0.20	Accuracy	R	1.73	1	0.12	*
Probe Positioner	0.050	Accuracy	R	1.73	1	0.03	*
Extrapolation/Interpolation	0.045	Tolerance	R	1.73	1	0.03	*
Resolution to 2mm error	0.21	Tolerance	Ν	1.00	1	0.21	
System Detection Limit	0.05	Tolerance	R	1.73	1	0.03	*
Readout Electronics	0.015	Tolerance	Ν	1.00	1	0.02	*
Integration Time	0.11	Tolerance	R	1.73	1	0.06	*
Response Time	0.033	Tolerance	R	1.73	1	0.02	*
Phantom Thickness	0.10	Tolerance	R	1.73	1	0.06	*
System Repeatability (Field x 2=power)	0.17	Tolerance	Ν	1.00	1	0.17	*
Test Sample Related							•
Device Positioning Vertical	0.2	Tolerance	R	1.73	1	0.12	*
Device Positioning Lateral	0.045	Tolerance	R	1.73	1	0.03	*
Device Holder and Phantom	0.1	Tolerance	R	1.73	1	0.06	*
Power Drift	0.21	Tolerance	R	1.73	1	0.12	
Combined Standard Uncertainty (k=1)						0.66	16.3%
Expanded Uncertainty [95% confidence]						1.31	32.6%
Expanded Uncertainty [95% confidence] on Field						0.66	16.3%

Notes:

1. Test equipments are calibrated according to techniques outlined in NIS81, NIS3003 and NIST Tech Note 1297. All equipments have traceability according to NIST. Measurement Uncertainties are defined in further detail in NIS 81 and NIST Tech Note 1297 and UKAS M3003.

2. * Uncertainty specifications from Schmidt & Partner Engineering AG (not site specific)

Measurement uncertainty reflects the quality and accuracy of a measured result as compared to the true value. Such statements are generally required when stating results of measurements so that it is clear to the intended audience that the results may differ when reproduced by different facilities. Measurement results vary due to the measurement uncertainty of the instrumentation, measurement technique, and test engineer. Most uncertainties are calculated using the tolerances of the instrumentation used in the measurement, the measurement setup variability, and the technique used in performing the test. While not generally included, the variability of the equipment under test also figures into the overall measurements (so-called Type A uncertainty). This may mean that the Hearing Aid immunity tests may have to be repeated by taking down the test setup and resetting it up so that there are a statistically significant number of repeat measurements to identify the measurement uncertainty. By combining the repeat measurements to identify the measurement uncertainty. By combining the repeat measurements to identify the measurement uncertainty. By and NIS 3003, the overall measurement uncertainty was estimated.

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13. TEST DATA

See following Attached Pages for Test Data.

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PCTEST Hearing-Aid Compatibility Facility

DUT: CD835V3 - SN1003

Type: CD835V3 Serial: 1003

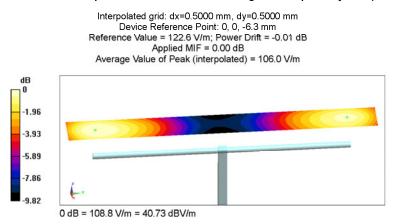
Communication System: CW; Frequency: 835 MHz;

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY5 Configuration:

- Probe: EF3DV3 SN4035; Calibrated: 1/16/2019;
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE4 Sn1415; Calibrated: 3/13/2019
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASY52, Version 52.10 (0);

835 MHz / 100mW HAC Dipole Validation at 15mm/Hearing Aid Compatibility Test (41x361x1):



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DUT: CD1880V3 - SN1137

Type: CD1880V3 Serial: 1137

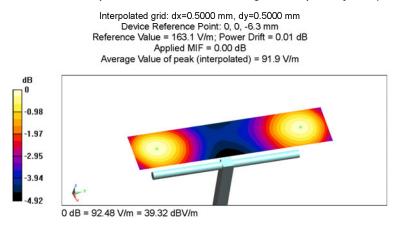
Communication System: CW; Frequency: 1880 MHz;

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY5 Configuration:

- Probe: EF3DV3 SN4035; Calibrated: 1/16/2019;
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE4 Sn1415; Calibrated: 3/13/2019
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASY52, Version 52.10 (0);

1880 MHz / 100mW HAC Dipole Validation at 15mm/Hearing Aid Compatibility Test (41x181x1):



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DUT: ZNFX320APM

Type: Portable Handset Serial: 02105 Backlight off Duty Cycle: 1:8.3

Communication System: GSM; Frequency: 824.2 MHz;

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY5 Configuration:

- Probe: EF3DV3 SN4035; Calibrated: 1/16/2019;
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn1415; Calibrated: 3/13/2019
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASY52, Version 52.10 (0);

GSM850 Low Channel/Hearing Aid Compatibility Test (101x101x1):

Interpolated grid: dx=0.5000 mm, dy=0.5000 mm Device Reference Point: 0, 0, -6.3 mm Reference Value = 54.25 V/m; Power Drift = -0.07 dB Applied MIF = 3.55 dB RF audio interference level = 35.55 dBV/m Emission category: M4

 MIF scaled E-field

 Grid 1 M4
 Grid 2 M4
 Grid 3 M4

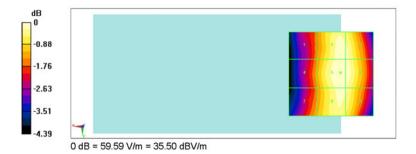
 34.01 dBV/m
 35.44 dBV/m
 35.38 dBV/m

 Grid 4 M4
 Grid 5 M4
 Grid 6 M4

 34.21 dBV/m
 35.55 dBV/m
 35.48 dBV/m

 Grid 7 M4
 Grid 8 M4
 Grid 9 M4

 34.32 dBV/m
 35.36 dBV/m
 35.3 dBV/m



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PCTEST Hearing-Aid Compatibility Facility

DUT: ZNFX320APM

Type: Portable Handset Serial: 02105 Backlight off Duty Cycle: 1:8.3

Communication System: GSM; Frequency: 1850.2 MHz;

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

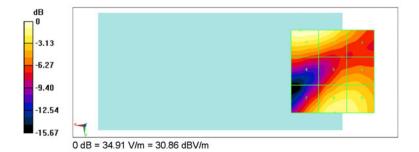
DASY5 Configuration:

- Probe: EF3DV3 SN4035; Calibrated: 1/16/2019;
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn1415; Calibrated: 3/13/2019
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASY52, Version 52.10 (0);

GSM1900 Low Channel /Hearing Aid Compatibility Test (101x101x1):

Interpolated grid: dx=0.5000 mm, dy=0.5000 mm Device Reference Point: 0, 0, -6.3 mm Reference Value = 14.21 V/m; Power Drift = -0.07 dB Applied MIF = 3.55 dB RF audio interference level = 30.91 dBV/m Emission category: M3

MIF scaled E-field							
Grid 1 M3	Grid 2 M3	Grid 3 M4					
30.91 dBV/m	30.48 dBV/m	27.26 dBV/m					
Grid 4 M4	Grid 5 M4	Grid 6 M4					
25.25 dBV/m	27.04 dBV/m	27.17 dBV/m					
Grid 7 M4	Grid 8 M4	Grid 9 M4					
28.02 dBV/m	29.87 dBV/m	29.54 dBV/m					



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14. CALIBRATION CERTIFICATES

The following pages include the probe calibration used to evaluate HAC for the DUT.

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Accreditation No.: SCS 0108

Accredited by the Swiss Accreditation Service (SAS) The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

Client PC Test Certificate No: EF3-4035_Jan19/2

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	EF3DV3- SN:4035) and a second	
Calibration procedure(s)	QA CAL-02.v9, QA Calibration proced evaluations in air	A CAL-25.v7 ure for E-field probes optimized f	or close near field
alibration date:	January 16, 2019		2/25/20
		al standards, which realize the physical units bability are given on the following pages and a	of measurements (SI).
Il calibrations have been cond calibration Equipment used (Ma		facility: environment temperature (22 \pm 3)°C a	ınd humidity < 70%.
Primona Standarda			
Primary Standards Power meter NRP	SN: 104778	Cal Date (Certificate No.)	Scheduled Calibration
Power sensor NRP-Z91	SN: 103244	04-Apr-18 (No. 217-02672/02673)	Apr-19
Power sensor NRP-Z91	SN: 103245	04-Apr-18 (No. 217-02672) 04-Apr-18 (No. 217-02673)	Apr-19
Reference 20 dB Attenuator	SN: S5277 (20x)	04-Apr-16 (No. 217-02673) 04-Apr-18 (No. 217-02682)	Apr-19 Apr-19
DAE4	SN: 789	14-Jan-19 (No. DAE4-789 Jan19)	Jan-20
Reference Probe ER3DV6	SN: 2328	09-Oct-18 (No. ER3-2328_Oct18)	Oct-19
	0.11.2020	00 000 10 (110: E113-2020_00010)	001713
Secondary Standards	ID	Check Date (in house)	Scheduled Check
Power meter E4419B	SN: GB41293874	06-Apr-16 (in house check Jun-18)	In house check: Jun-20
Power sensor E4412A	SN: MY41498087	06-Apr-16 (in house check Jun-18)	In house check: Jun-20
Power sensor E4412A	SN: 000110210	06-Apr-16 (in house check Jun-18)	In house check: Jun-20
RF generator HP 8648C	SN: US3642U01700	04-Aug-99 (in house check Jun-18)	In house check: Jun-20
Network Analyzer E8358A	SN: US41080477	31-Mar-14 (in house check Oct-18)	In house check: Oct-19
MA	Name	Function	Classification
alibrated by:	Manu Seitz	Laboratory Technician	Signature
			and -
pproved by:	Katja Pokovic	Technical Manager	All -

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Glossary:	
NORMx,y,z	sensitivity in free space
DCP	diode compression point
CF	crest factor (1/duty_cycle) of the RF signal
ABCD	modulation dependent linearization parameters

CF	crest factor (1/duty_cycle) of the RF signal
A, B, C, D	modulation dependent linearization parameters
En	incident E-field orientation normal to probe axis
Ep	incident E-field orientation parallel to probe axis
Polarization φ	φ rotation around probe axis
Polarization 9	ϑ rotation around an axis that is in the plane normal to probe axis (at measurement center), i.e., $\vartheta = 0$ is normal to probe axis
Connector Angle	information used in DASY system to align probe sensor X to the robot coordinate system

Calibration is Performed According to the Following Standards:

- a) IEEE Std 1309-2005, "IEEE Standard for calibration of electromagnetic field sensors and probes, excluding antennas, from 9 kHz to 40 GHz", December 2005
- b) CTIA Test Plan for Hearing Aid Compatibility, Rev 3.1.1, May 2017

Methods Applied and Interpretation of Parameters:

- NORMx, y, z: Assessed for E-field polarization 9 = 0 for XY sensors and 9 = 90 for Z sensor (f ≤ 900 MHz in TEM-cell; f > 1800 MHz: R22 waveguide).
- NORM(f)x,y,z = NORMx,y,z * frequency_response (see Frequency Response Chart).
- DCPx,y,z: DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal (no uncertainty required). DCP does not depend on frequency nor media.
- PAR: PAR is the Peak to Average Ratio that is not calibrated but determined based on the signal characteristics
- Ax,y,z; Bx,y,z; Cx,y,z; Dx,y,z; VRx,y,z: A, B, C, D are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. VR is the maximum calibration range expressed in RMS voltage across the diode.
- Spherical isotropy (3D deviation from isotropy): in a locally homogeneous field realized using an open waveguide setup.
- Sensor Offset: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.
- Connector Angle: The angle is assessed using the information gained by determining the NORMx (no uncertainty required).

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DASY/EASY - Parameters of Probe: EF3DV3 - SN:4035

Basic Calibration Parameters

	Sensor X	Sensor Y	Sensor Z	Unc (k=2)
Norm $(\mu V/(V/m)^2)$	0.90	0.74	1.20	± 10.1 %
DCP (mV) ^B	96.8	98.5	95.3	

Calibration results for Frequency Response (30 MHz - 6 GHz)

Frequency MHz	Target E-Field V/m	Measured E-field (En) V/m	Deviation E-normal in %	Measured E-field (Ep) V/m	Deviation E-normal in %	Unc (k=2) %
30	77.3	76.8	-0.6%	77.3	0.1%	± 5.1 %
100	77.3	78.2	1.2%	77.8	0.7%	± 5.1 %
450	77.1	78.2	1.5%	77.8	0.9%	± 5.1 %
600	77.1	77.8	0.9%	77.5	0.5%	± 5.1 %
750	77.3	77.7	0.5%	77.2	-0.1%	± 5.1 %
1800	140.3	136.9	-2.4%	137.2	-2.2%	± 5.1 %
2000	133.0	129.4	-2.8%	129.4	-2.7%	± 5.1 %
2200	124.8	121.5	-2.7%	122.7	-1.7%	± 5.1 %
2500	123.7	120.7	-2.4%	121.9	-1.5%	± 5.1 %
3000	78.8	74.8	-5.0%	76.1	-3.5%	± 5.1 %
3500	256.3	248.1	-3.2%	246.0	-4.0%	± 5.1 %
3700	249.7	239.2	-4.2%	239.0	-4.3%	± 5.1 %
5200	50.7	50.7	-0.1%	51.2	0.9%	± 5.1 %
5500	49.6	48.9	-1.5%	48.7	-1.9%	± 5.1 %
5800	48.9	49.1	0.4%	49.3	0.8%	± 5.1 %

Calibration Results for Modulation Response

UID	Communication System Name		A dB	B dB√uV	С	D dB	VR mV	Max dev.	Unc [≞] (k=2)
0	CW	Х	0.0	0.0	1.0	0.00	141.5	+ 3.3 %	±4.7 %
		Y	0.0	0.0	1.0		125.6		
		Y	0.0	0.0	1.0		125.1		

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

⁸ Numerical linearization parameter: uncertainty not required.
^E Uncertainty is determined using the max. deviation from linear response applying rectangular distribution and is expressed for the square of the field value.

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EF3DV3 - SN:4035

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DASY/EASY - Parameters of Probe: EF3DV3 - SN:4035

Sensor Frequency Model Parameters

	Sensor X	Sensor Y	Sensor Z
Frequency Corr. (LF)	0.28	0.21	5.68
Frequency Corr. (HF)	2.82	2.82	2.82

Other Probe Parameters

Sensor Arrangement	Rectangular
Connector Angle (°)	57.9
Mechanical Surface Detection Mode	enabled
Optical Surface Detection Mode	disabled
Probe Overall Length	337 mm
Probe Body Diameter	12 mm
Tip Length	25 mm
Tip Diameter	4 mm
Probe Tip to Sensor X Calibration Point	1.5 mm
Probe Tip to Sensor Y Calibration Point	1.5 mm
Probe Tip to Sensor Z Calibration Point	1.5 mm

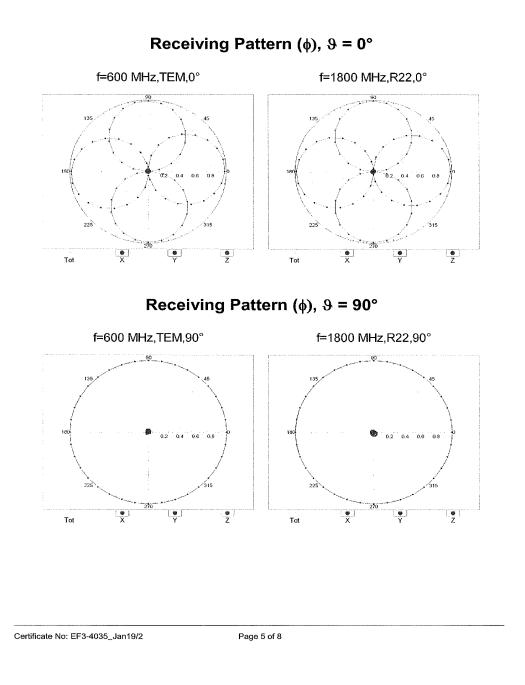
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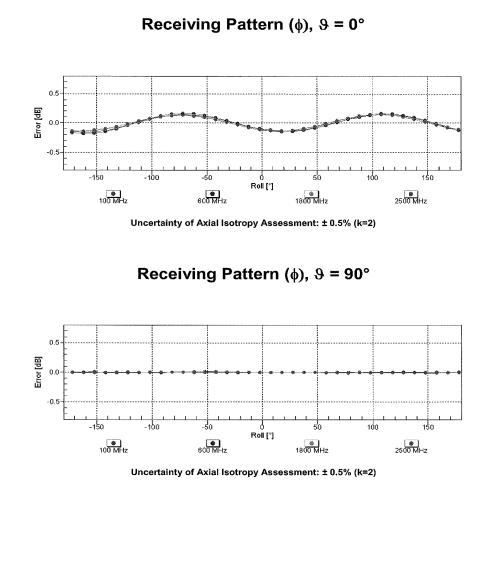
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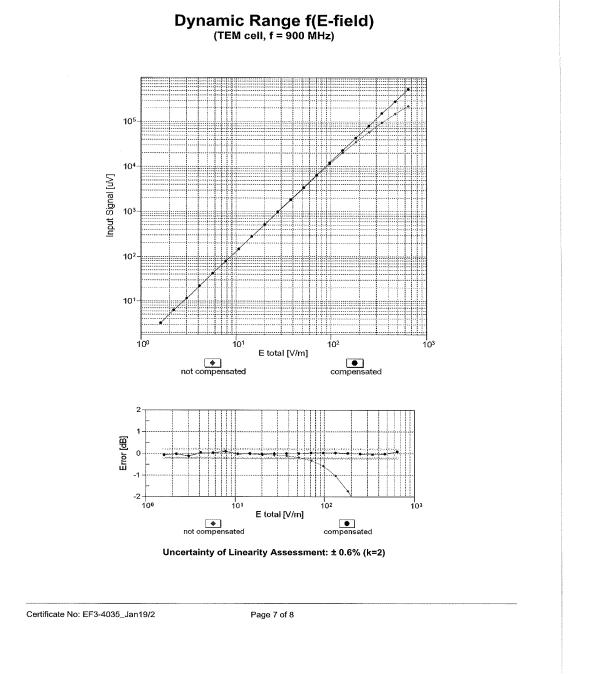
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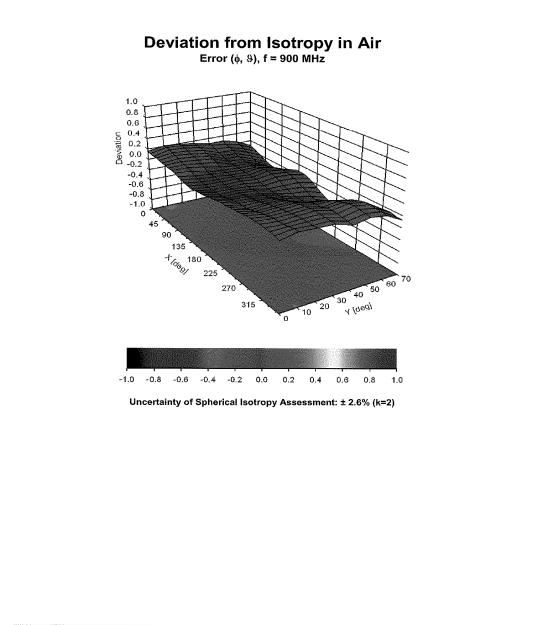
EF3DV3 - SN:4035

January 16, 2019



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January 16, 2019



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Accreditation No.: SCS 0108

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Client PC Test

Certificate No: CD835V3-1003_Feb19

Object	CD835V3 - SN:	1003	
Calibration procedure(s)	QA CAL-20.v7 Calibration Proc	edure for Validation Sources in a	ir /04f 3/19/2014
Calibration date:	February 19, 20	19	
The measurements and the unc	ertainties with confidence pucted in the closed laborate	ional standards, which realize the physical un probability are given on the following pages ar ny facility: environment temperature (22 ± 3)°(nd are part of the certificate.
Calibration Equipment used (M8	1		
Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Power meter NRP	SN: 104778	04-Apr-18 (No. 217-02672/02673)	Apr-19
ower sensor NRP-Z91	SN: 103244	04-Apr-18 (No. 217-02672)	Apr-19
ower sensor NRP-Z91	SN: 103245	04-Apr-18 (No. 217-02673)	Apr-19
eference 20 dB Attenuator	SN: 5058 (20k)	04-Apr-18 (No. 217-02682)	Apr-19
ype-N mismatch combination robe EF3DV3	SN: 5047.2 / 06327	04-Apr-18 (No. 217-02683)	Apr-19
AE4	SN: 4013	03-Jan-19 (No. EF3-4013_Jan19)	Jan-20
AC4	SN: 781	09-Jan-19 (No. DAE4-781_Jan19)	Jan-20
econdary Standards	ID #	Check Date (in house)	Scheduled Check
ower meter Agilent 4419B	SN: GB42420191	09-Oct-09 (in house check Oct-17)	In house check: Oct-20
ower sensor HP E4412A	SN: US38485102	05-Jan-10 (in house check Oct-17)	In house check: Oct-20
ower sensor HP 8482A	SN: US37295597	09-Oct-09 (in house check Oct-17)	In house check: Oct-20
F generator R&S SMT-06	SN: 832283/011	27-Aug-12 (in house check Oct-17)	In house check: Oct-20
etwork Analyzer HP 8358A	SN: US41080477	31-Mar-14 (in house check Oct-18)	In house check: Oct-19
	Name	Function	Signature
alibrated by:	Claudio Leubler	Laboratory Technician	$()\Sigma$
pproved by:	Katja Pokovic	Technical Manager	Elle

Certificate No: CD835V3-1003_Feb19

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References

[1]

ANSI-C63.19-2011

American National Standard, Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.

Methods Applied and Interpretation of Parameters:

- Coordinate System: y-axis is in the direction of the dipole arms. z-axis is from the basis of the antenna (mounted on the table) towards its feed point between the two dipole arms. x-axis is normal to the other axes. In coincidence with the standards [1], the measurement planes (probe sensor center) are selected to be at a distance of 15 mm above the top metal edge of the dipole arms.
- Measurement Conditions: Further details are available from the hardcopies at the end of the certificate. All
 figures stated in the certificate are valid at the frequency indicated. The forward power to the dipole connector
 is set with a calibrated power meter connected and monitored with an auxiliary power meter connected to a
 directional coupler. While the dipole under test is connected, the forward power is adjusted to the same level.
- Antenna Positioning: The dipole is mounted on a HAC Test Arch phantom using the matching dipole positioner with the arms horizontal and the feeding cable coming from the floor. The measurements are performed in a shielded room with absorbers around the setup to reduce the reflections. It is verified before the mounting of the dipole under the Test Arch phantom, that its arms are perfectly in a line. It is installed on the HAC dipole positioner with its arms parallel below the dielectric reference wire and able to move elastically in vertical direction without changing its relative position to the top center of the Test Arch phantom. The vertical distance to the probe is adjusted after dipole mounting with a DASY5 Surface Check job. Before the measurement, the distance between phantom surface and probe tip is verified. The proper measurement distance is selected by choosing the matching section of the HAC Test Arch phantom with the proper device reference point (upper surface of the dipole) and the matching grid reference point (tip of the probe) considering the probe sensor offset. The vertical distance to the probe is essential for the accuracy.
- Feed Point Impedance and Return Loss: These parameters are measured using a HP 8753E Vector Network Analyzer. The impedance is specified at the SMA connector of the dipole. The influence of reflections was eliminating by applying the averaging function while moving the dipole in the air, at least 70cm away from any obstacles.
- E-field distribution: E field is measured in the x-y-plane with an isotropic ER3D-field probe with 100 mW forward power to the antenna feed point. In accordance with [1], the scan area is 20mm wide, its length exceeds the dipole arm length (180 or 90mm). The sensor center is 15 mm (in z) above the metal top of the dipole arms. Two 3D maxima are available near the end of the dipole arms. Assuming the dipole arms are perfectly in one line, the average of these two maxima (in subgrid 2 and subgrid 8) is determined to compensate for any non-parallelity to the measurement plane as well as the sensor displacement. The E-field value stated as calibration value represents the maximum of the interpolated 3D-E-field, in the plane above the dipole surface.

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

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Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V52.10.2
Phantom	HAC Test Arch	
Distance Dipole Top - Probe Center	15 mm	
Scan resolution	dx, dy = 5 mm	
Frequency	835 MHz ± 1 MHz	
Input power drift	< 0.05 dB	

Maximum Field values at 835 MHz

E-field 15 mm above dipole surface	condition	Interpolated maximum	
Maximum measured above high end	100 mW input power	105.2 V/m = 40.44 dBV/m	
Maximum measured above low end	100 mW input power	105.1 V/m = 40.43 dBV/m	
Averaged maximum above arm	100 mW input power	105.2 V/m ± 12.8 % (k=2)	

Appendix (Additional assessments outside the scope of SCS 0108)

Antenna Parameters

Frequency	Return Loss	Impedance
800 MHz	17.6 dB	40.4 Ω - 7.2 jΩ
835 MHz	25.8 dB	52.2 Ω + 4.7 jΩ
880 MHz	16.9 dB	62.1 Ω - 10.5 jΩ
900 MHz	16.9 dB	52.2 Ω - 14.6 ϳΩ
945 MHz	21.6 dB	51.8 Ω + 8.3 jΩ

3.2 Antenna Design and Handling

The calibration dipole has a symmetric geometry with a built-in two stub matching network, which leads to the enhanced bandwidth.

The dipole is built of standard semirigid coaxial cable. The internal matching line is open ended. The antenna is therefore open for DC signals.

Do not apply force to dipole arms, as they are liable to bend. The soldered connections near the feedpoint may be damaged. After excessive mechanical stress or overheating, check the impedance characteristics to ensure that the internal matching network is not affected.

After long term use with 40W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

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Impedance Measurement Plot

le <u>V</u> iew <u>⊂</u> hannel Sw <u>e</u> ep	Calibration <u>Trace</u> <u>Scale</u>	M <u>a</u> rker S <u>y</u> stem <u>W</u> indo	ow <u>H</u> elp		
10.00 (18.611)			11:	809.000000 MHz	-17.586 dB
5.00					25.837 dB
0.00			3:	880.000000 MHz	-16.937 dB
-5.00			4:	900.100000 MHz 945.00000 MHz	-16.970 38
			7 12	HAD THUR MHP	-21.641dB
-10.00		∖ /	·		
-15.00		\rightarrow $+$ $+$			
-20.00		4 63/			
-25.00					
30.00					
35.00					
40.00 Ch 1 Avg = 20					
Ch1: Start 335.000 MHz				Stop	1.33500 GHz
	والمراجع			viop	1.00000 012
		~~ <u>~</u>			
			1:	800.000000 MHz	40.420 Ω
		A	1: >2:	800.000000 MHz 27.676 pF	40.420 Ω -7.1883 Ω
			>2:	800.000000 MHz 27.676 pF 835.000000 MHz 902.00 pH	40.420 Ω
				800.000000 MHz 27.676 pF 835.000000 MHz 902.00 pH 880.000000 MHz	40.420 Ω -7.1893 Ω 52.216 Ω 4.7323 Ω 62.123 Ω
	<u> </u>		>2:	800.000000 MHz 27.676 pF 835.000000 MHz 902.00 pH 880.000000 MHz 17.263 pF	40.420 Ω -7.1883 Ω 52.216 Ω 4.7323 Ω 62.123 Ω -10.477 Ω
	Ŕ		>2:	800.000000 MHz 27.676 pF 835.00000 MHz 902.00 pH 880.000000 MHz 17.263 pF 900.000000 MHz	40.420 Ω -7.1883 Ω 52.216 Ω 4.7323 Ω 62.123 Ω -10.477 Ω 52.237 Ω
	Ŕ		>2:	800.000000 MHz 27.676 pF 835.000000 MHz 902.00 pH 880.000000 MHz 17.263 pF	40.420 Ω -7.1883 Ω 52.216 Ω 4.7323 Ω 62.123 Ω -10.477 Ω
			>2: 3: 4:	800.000000 MHz 27.878 pF 835.000000 MHz 902.00 pH 880.000000 MHz 17.263 pF 900.00000 MHz 12.080 pF	40.420 Ω -7.1883 Ω 52.216 Ω 4.7323 Ω 62.123 Ω -10.477 Ω 52.237 Ω -14.639 Ω
			>2: 3: 4:	800.00000 MHz 27.876 pF 835.00000 MHz 902.00 pH 890.00000 MHz 17.263 pF 900.00000 MHz 12.080 pF 945.000000 MHz	40.420 Ω -7.1883 Ω 52.216 Ω 4.7323 Ω 62.123 Ω -10.477 Ω 52.237 Ω -14.639 Ω 51.835 Ω
			>2: 3: 4:	800.00000 MHz 27.876 pF 835.00000 MHz 902.00 pH 890.00000 MHz 17.263 pF 900.00000 MHz 12.080 pF 945.000000 MHz	40.420 Ω -7.1883 Ω 52.216 Ω 4.7323 Ω 62.123 Ω -10.477 Ω 52.237 Ω -14.639 Ω 51.835 Ω
			>2: 3: 4:	800.00000 MHz 27.876 pF 835.00000 MHz 902.00 pH 890.00000 MHz 17.263 pF 900.00000 MHz 12.080 pF 945.000000 MHz	40.420 Ω -7.1883 Ω 52.216 Ω 4.7323 Ω 62.123 Ω -10.477 Ω 52.237 Ω -14.639 Ω 51.835 Ω
Ch 1 Ava = 20			>2: 3: 4:	800.00000 MHz 27.876 pF 835.00000 MHz 902.00 pH 890.00000 MHz 17.263 pF 900.00000 MHz 12.080 pF 945.000000 MHz	40.420 Ω -7.1883 Ω 52.216 Ω 4.7323 Ω 62.123 Ω -10.477 Ω 52.237 Ω -14.639 Ω 51.835 Ω
Ch 1 Avg = 20 Ch1: Start 335.000 MHz	_		>2: 3: 4:	800.00000 MHz 27.876 pF 835.00000 MHz 902.00 pH 880.000000 MHz 17.263 pF 900.00000 MHz 12.080 pF 945.000000 MHz 1.3906 nH	40.420 Ω -7.1883 Ω 52.216 Ω 4.7323 Ω 62.123 Ω -10.477 Ω 52.237 Ω -14.639 Ω 51.835 Ω

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DASY5 E-field Result

Date: 19.02.2019

Test Laboratory: SPEAG Lab2

DUT: HAC-Dipole 835 MHz; Type: CD835V3; Serial: CD835V3 - SN: 1003

Communication System: UID 0 - CW ; Frequency: 835 MHz Medium parameters used: $\sigma = 0$ S/m, $\epsilon_r = 1$; $\rho = 0$ kg/m³ Phantom section: RF Section Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

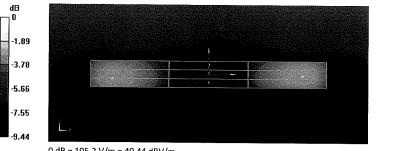
DASY52 Configuration:

- Probe: EF3DV3 SN4013; ConvF(1, 1, 1) @ 835 MHz; Calibrated: 03.01.2019
- Sensor-Surface: (Fix Surface)
- ٠ Electronics: DAE4 Sn781; Calibrated: 09.01.2019
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070 ٠
- DASY52 52.10.2(1495); SEMCAD X 14.6.12(7450)

Dipole E-Field measurement @ 835MHz/E-Scan - 835MHz d=15mm/Hearing Aid Compatibility Test (41x361x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm Device Reference Point: 0, 0, -6.3 mm

Reference Value = 127.3 V/m; Power Drift = 0.04 dB Applied MIF = 0.00 dBRF audio interference level = 40.44 dBV/mEmission category: M3

MIF scaled E-field			
	Grid 2 M3 40.43 dBV/m	Grid 3 M3 40.43 dBV/m	
Grid 4 M4		Grid 6 M4	
		Grid 9 M3 4 0.36 dBV/m	



0 dB = 105.2 V/m = 40.44 dBV/m

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Accreditation No.: SCS 0108

Client PC Test Certificate No: CD1880V3-1137_Feb19 CALIBRATION CERTIFICATE Object CD1880V3 - SN: 1137 Calibration procedure(s) QA CAL-20.v7 Calibration Procedure for Validation Sources in air 3/19/201 Calibration date: February 19, 2019 This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate. All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%. Calibration Equipment used (M&TE critical for calibration) Primary Standards ID # Cal Date (Certificate No.) Scheduled Calibration Power meter NRP SN: 104778 04-Apr-18 (No. 217-02672/02673) Apr-19 Power sensor NRP-Z91 SN: 103244 04-Apr-18 (No. 217-02672) Apr-19 Power sensor NRP-Z91 SN: 103245 04-Apr-18 (No. 217-02673) Apr-19 Reference 20 dB Attenuator SN: 5058 (20k) 04-Apr-18 (No. 217-02682) Apr-19 Type-N mismatch combination SN: 5047.2 / 06327 04-Apr-18 (No. 217-02683) Apr-19 Probe EF3DV3 SN: 4013 03-Jan-19 (No. EF3-4013_Jan19) Jan-20 DAE4 SN: 781 09-Jan-19 (No. DAE4-781_Jan19) Jan-20 Secondary Standards ID # Check Date (in house) Scheduled Check Power meter Agilent 4419B SN: GB42420191 09-Oct-09 (in house check Oct-17) In house check: Oct-20 Power sensor HP E4412A SN: US38485102 05-Jan-10 (in house check Oct-17) In house check: Oct-20 Power sensor HP 8482A SN: US37295597 09-Oct-09 (in house check Oct-17) In house check: Oct-20 RF generator R&S SMT-06 SN: 832283/011 27-Aug-12 (in house check Oct-17) In house check: Oct-20 Network Analyzer HP 8358A SN: US41080477 31-Mar-14 (in house check Oct-18) In house check: Oct-19 Name Function Calibrated by: Claudio Leubler Laboratory Technician Approved by: Katja Pokovic **Technical Manager** Issued: February 20, 2019 This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

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The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

References

[1] ANSI-C63.19-2011

American National Standard, Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids,

Methods Applied and Interpretation of Parameters:

- Coordinate System: y-axis is in the direction of the dipole arms. z-axis is from the basis of the antenna (mounted on the table) towards its feed point between the two dipole arms. x-axis is normal to the other axes. In coincidence with the standards [1], the measurement planes (probe sensor center) are selected to be at a distance of 15 mm above the top metal edge of the dipole arms.
- Measurement Conditions: Further details are available from the hardcopies at the end of the certificate. All
 figures stated in the certificate are valid at the frequency indicated. The forward power to the dipole connector
 is set with a calibrated power meter connected and monitored with an auxiliary power meter connected to a
 directional coupler. While the dipole under test is connected, the forward power is adjusted to the same level.
- Antenna Positioning: The dipole is mounted on a HAC Test Arch phantom using the matching dipole positioner with the arms horizontal and the feeding cable coming from the floor. The measurements are performed in a shielded room with absorbers around the setup to reduce the reflections. It is verified before the mounting of the dipole under the Test Arch phantom, that its arms are perfectly in a line. It is installed on the HAC dipole positioner with its arms parallel below the dielectric reference wire and able to move elastically in vertical direction without changing its relative position to the top center of the Test Arch phantom. The vertical distance to the probe is adjusted after dipole mounting with a DASY5 Surface Check job. Before the measurement, the distance between phantom surface and probe tip is verified. The proper measurement distance is selected by choosing the matching section of the HAC Test Arch phantom with the proper device reference point (upper surface of the dipole) and the matching grid reference point (tip of the probe) considering the probe sensor offset. The vertical distance to the probe is assential for the accuracy.
- Feed Point Impedance and Return Loss: These parameters are measured using a HP 8753E Vector Network Analyzer. The impedance is specified at the SMA connector of the dipole. The influence of reflections was eliminating by applying the averaging function while moving the dipole in the air, at least 70cm away from any obstacles.
- E-field distribution: E field is measured in the x-y-plane with an isotropic ER3D-field probe with 100 mW forward power to the antenna feed point. In accordance with [1], the scan area is 20mm wide, its length exceeds the dipole arm length (180 or 90mm). The sensor center is 15 mm (in z) above the metal top of the dipole arms. Two 3D maxima are available near the end of the dipole arms. Assuming the dipole arms are perfectly in one line, the average of these two maxima (in subgrid 2 and subgrid 8) is determined to compensate for any non-parallelity to the measurement plane as well as the sensor displacement. The E-field value stated as calibration value represents the maximum of the interpolated 3D-E-field, in the plane above the dipole surface.

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

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Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V52.10.2
Phantom	HAC Test Arch	
Distance Dipole Top - Probe Center	15 mm	
Scan resolution	dx, dy = 5 mm	
Frequency	1730 MHz ± 1 MHz 1880 MHz ± 1 MHz	
Input power drift	< 0.05 dB	

Maximum Field values at 1730 MHz

E-field 15 mm above dipole surface	condition	Interpolated maximum
Maximum measured above high end	100 mW input power	95.0 V/m = 39.55 dBV/m
Maximum measured above low end	100 mW input power	94.9 V/m = 39.55 dBV/m
Averaged maximum above arm	100 mW input power	95.0 V/m ± 12.8 % (k=2)

Maximum Field values at 1880 MHz

.

E-field 15 mm above dipole surface	condition	Interpolated maximum
Maximum measured above high end	100 mW input power	88.9 V/m = 38.98 dBV/m
Maximum measured above low end	100 mW input power	86.6 V/m = 38.75 dBV/m
Averaged maximum above arm	100 mW input power	87.8 V/m ± 12.8 % (k=2)

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Appendix (Additional assessments outside the scope of SCS 0108)

Antenna Parameters

Nominal Frequencies

Frequency	Return Loss	Impedance
1730 MHz	22.5 dB	54.4 Ω + 6.5 jΩ
1880 MHz	21.1 dB	55.9 Ω + 7.2 jΩ
1900 MHz	21.0 dB	59.0 Ω + 3.6 jΩ
1950 MHz	27.3 dB	53.0 Ω - 3.3 jΩ
2000 MHz	20.3 dB	42.4 Ω + 4.8 jΩ

3.2 Antenna Design and Handling

The calibration dipole has a symmetric geometry with a built-in two stub matching network, which leads to the enhanced bandwidth.

The dipole is built of standard semirigid coaxial cable. The internal matching line is open ended. The antenna is therefore open for DC signals.

Do not apply force to dipole arms, as they are liable to bend. The soldered connections near the feedpoint may be damaged. After excessive mechanical stress or overheating, check the impedance characteristics to ensure that the internal matching network is not affected.

After long term use with 40W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

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Impedance Measurement Plot

-23.00 -28.00 -33.00 -38.00			1 V	7	3	/5			
43.00 Ch1; S	Ch 1 Avg = Start 1.38000 (20 GHz	اــــــا در			<	1:	Stop 2 1.730000 GHz 601.12 pH	2.38000 GHz 54.408 Ω 6.5341 Ω
			H	X	X		2: 3: 4:	1.880000 GHz 609.67 pH 1.900000 GHz 303.81 pH 1.950000 GHz	55.885 Ω 7.2016 Ω 59.017 Ω 3.6269 Ω 52.957 Ω

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DASY5 E-field Result

Date: 19.02.2019

Test Laboratory: SPEAG Lab2

DUT: HAC Dipole 1880 MHz; Type: CD1880V3; Serial: CD1880V3 - SN: 1137

Communication System: UID 0 - CW ; Frequency: 1880 MHz, Frequency: 1730 MHz Medium parameters used: $\sigma = 0$ S/m, $\epsilon_r = 1$; $\rho = 0$ kg/m³ Phantom section: RF Section Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY52 Configuration:

- Probe: EF3DV3 SN4013; ConvF(1, 1, 1) @ 1880 MHz, ConvF(1, 1, 1) @ 1730 MHz; Calibrated: 03.01.2019
- Sensor-Surface: (Fix Surface) .
- Electronics: DAE4 Sn781; Calibrated: 09.01.2019 Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070 .
- ٠

DASY52 52.10.2(1495); SEMCAD X 14.6.12(7450)

Dipole E-Field measurement @ 1880MHz/E-Scan - 1880MHz d=15mm/Hearing Aid Compatibility Test (41x181x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm Device Reference Point: 0, 0, -6.3 mm Reference Value = 151.5 V/m; Power Drift = 0.02 dB Applied MIF = 0.00 dBRF audio interference level = 38.98 dBV/m Emission category: M2

MIF scaled E-field

Grid 1 M2	Grid 2 M2	Grid 3 M2
38.55 dBV/m	38.98 dBV/m	38.93 dBV/m
Grid 4 M2	Grid 5 M2	Grid 6 M2
35.71 dBV/m	35.97 dBV/m	35.96 dBV/m
Grid 7 M2	Grid 8 M2	Grid 9 M2
38.31 dBV/m	38.75 dBV/m	38.73 dBV/m

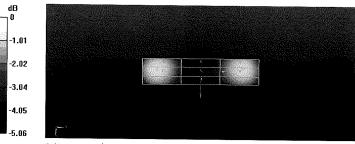
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Dipole E-Field measurement @ 1880MHz /E-Scan - 1730MHz d=15mm/Hearing Aid Compatibility Test (41x181x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm Device Reference Point: 0, 0, -6.3 mm Reference Value = 165.0 V/m; Power Drift = 0.03 dB Applied MIF = 0.00 dB RF audio interference level = 39.55 dBV/m Emission category: M2

	Grid 2 M2 39.55 dBV/m	Grid 3 M2 39.51 dBV/m
	Grid 5 M2	
36.57 dBV/m	36.95 dBV/m	36.95 dBV/m
Grid 7 M2	Grid 8 M2	Grid 9 M2
39.05 dBV/m	39.55 dBV/m	39.53 dBV/m



0 dB = 88.87 V/m = 38.98 dBV/m

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15. CONCLUSION

The measurements indicate that the wireless communications device complies with the HAC limits specified in accordance with the ANSI C63.19 Standard and FCC WT Docket No. 01-309 RM-8658. Precise laboratory measures were taken to assure repeatability of the tests. The tested device complies with the requirements in respect to all parameters specific to the test. The test results and statements relate only to the item(s) tested.

Please note that the M-rating for this equipment only represents the field interference possible against a hypothetical and typical hearing aid. The measurement system and techniques presented in this evaluation are proposed in the ANSI standard as a means of best approximating wireless device compatibility with a hearing-aid. The literature is under continual re-construction.

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